

R-IN32M4-CL3

Compared to conventional technologies, Ethernet communications in the industrial field are strongly required to have high-performance functions such as higher speed real-time response. These requirements are not necessarily realized by traditional methods such as making the Ethernet processing itself hardware or using a dedicated CPU for high-speed network processing.

The R-IN32M4-CL3 Ethernet communications LSI from Renesas Electronics has the following functions to realize “higher speed real-time response” and “high-accuracy communications control (low jitter communications)” which are important for Ethernet communications in the factory automation field.

- CPU
 - Integrated Arm® Cortex®-M4 core
 - Integrated hardware real-time OS accelerator (HW-RTOS)
- Peripheral
 - Timers, WDT, I²C, UART, CSI, CAN, and general-purpose I/O ports (GPIO)
 - Serial flash memory controller
- External memory/external MCU (microcontroller) interface
 - External memory connection mode: 16- or 32-bit bus connection to external devices such as SRAM
 - External MCU connection mode: 16- or 32-bit bus connection to host MCU
- Ethernet
 - Integrated Gigabit Ethernet MAC
 - Integrated switching hub with cut-through transfer, IEEE 1588 timer, and Device Level Ring (DLR) functions
 - Integrated 2-port 10/100/1000BASE-PHY
 - Dedicated DMA controller and buffer for the network processor
- Supported industrial Ethernet protocol
 - CC-Link IE Field intelligent device station and remote device station
 - CC-Link IE TSN remote station (authentication Classes: A and B)
 - PROFINET RT
 - EtherNet/IP
 - Modbus TCP
- Target application
 - Remote I/O
 - Inverter and servo drive
 - Industrial Ethernet communication unit
- Others
 - Pin assignment considering a replacement from R-IN32M4-CL2
 - Integrated 2.5 V regulator for PHY

1. Overview

1.1 Functional Overview

Table 1.1 Functional Overview of R-IN32M4-CL3 (1/3)

Product		R9A06G064MGBG (23 mm Square Package)	R9A06G064SGBG (17 mm Square Package)
Item			
CPU core		Arm Cortex-M4 32-bit RISC CPU + Real-Time OS Accelerator (Hardware Real-Time OS)	
	Operating frequency	100 MHz	
	Instruction set	Thumb®-2 instruction Armv7-M architecture	
	Floating-point UNIT	Armv7M FPv4-SP (32-bit single precision)	
	Instruction RAM	768 Kbytes (RAM with ECC)	
	Data RAM	512 Kbytes (RAM with ECC)	
	Buffer RAM	64 Kbytes (RAM with ECC)	
	Network RAM	128 Kbytes (RAM with ECC)	
	Internal system bus	32-bit system bus at 100 MHz (AHB-Lite) 64-bit system bus at 125 MHz (AXI) 128-bit communication bus at 100 MHz	
	DMA function (system bus side)	4 channels + 1 channel (for real-time port), Supports software and various interrupt-triggered DMA.	
	Boot modes	Serial flash ROM boot, External memory boot, External MCU boot	
	Support for external memory access	<ul style="list-style-type: none"> • Bus-size selection (16 or 32 bits) • Paged ROM/ROM/SRAM interface • Synchronous burst memory interface • Programmable wait function 	
	Chip select signals for static memory	4-line	4- or 3-line*1
	External memory space	256 Mbytes	256 or 192 Mbytes
	External MCU interface	<ul style="list-style-type: none"> • Bus-size selection (16 or 32 bits) • General-purpose interface for static memory • Address space: 2 Mbytes (Instruction RAM, Data RAM, Register area) • Internal address space mapping switching function 	
	Serial flash ROM memory controller	<ul style="list-style-type: none"> • Supports serial interface compatible with SPI of companies. • Supports direct boot from serial memory device. • Supports Fast Read, Fast Read Dual Output, Fast Read Dual I/O, Fast Read Quad Output, and Fast Read Quad I/O modes. • Direct layout in memory space 	
	Interrupt	• 30 external interrupt ports	

Note 1. When using an asynchronous SRAM controller in the 17 mm square package, the external memory areas of CSZ0–CSZ2 can be accessed.

Table 1.1 Functional Overview of R-IN32M4-CL3 (2/3)

Product		R9A06G064MGBG (23 mm Square Package)	R9A06G064SGBG (17 mm Square Package)
Item			
Internal peripheral modules			
I/O port		CMOS I/O: 106 maximum	CMOS I/O: 101 maximum
Timers (4 sub-systems)		<ul style="list-style-type: none"> • Internal timer of hardware RTOS • Internal timer of the CPU • 32-bit timer (4 channels) • 16-bit timer (16 channels) 	
Watchdog timer		<ul style="list-style-type: none"> • 1 channel • Software-triggered start mode • Watchdog error response options: <ul style="list-style-type: none"> – Generation of a non-maskable interrupt (NMI) – Generation of a reset • Interrupt when the counter reaches 75% of its overflow value 	
Asynchronous serial interface		<ul style="list-style-type: none"> • 2 channels • Full duplex transfer • FIFOs: 10 bits × 16 receive and 8 bits × 16 transmit • Support output of receive errors and status • Character length: 7 or 8 bits • Parity bit options: Odd, even, 0, none • Transmit stop bits: 1 bit or 2 bits 	
I ² C serial interface		<ul style="list-style-type: none"> • 2 channels • Operating modes: Normal or high-speed • Transfer modes: Single-transfer mode or continuous-transfer mode • Transfer data length: 8 bits 	
CAN controller		<ul style="list-style-type: none"> • 2 channels • Conforming to ISO11898 • Support for transmission and reception of standard and expanded frames • Transfer rate: Up to 1 Mbps 	Not available
Clocked serial interface		<ul style="list-style-type: none"> • 2 channels • Synchronized serial data transmission by three-wire system • Master mode or slave mode selectable • Built-in baud-rate generator • Transfer data length: 7 to 16 bits 	
10/100/1000Mbps Ethernet MAC		<ul style="list-style-type: none"> • 1 channel • Built-in 2-port switch 	
Ethernet PHY		<ul style="list-style-type: none"> • 2 ports IEEE 802.3 • 10BASE-T, 100BASE-TX, 1000BASE-T 	
CC-Link IE		Two types of CC-Link IE (CC-Link IE Field and CC-Link IE TSN) are supported. They can be used exclusively	
	CC-Link IE Field	CC-Link IE Field (intelligent device station / remote device station)	
	CC-Link IE TSN	CC-Link IE TSN	

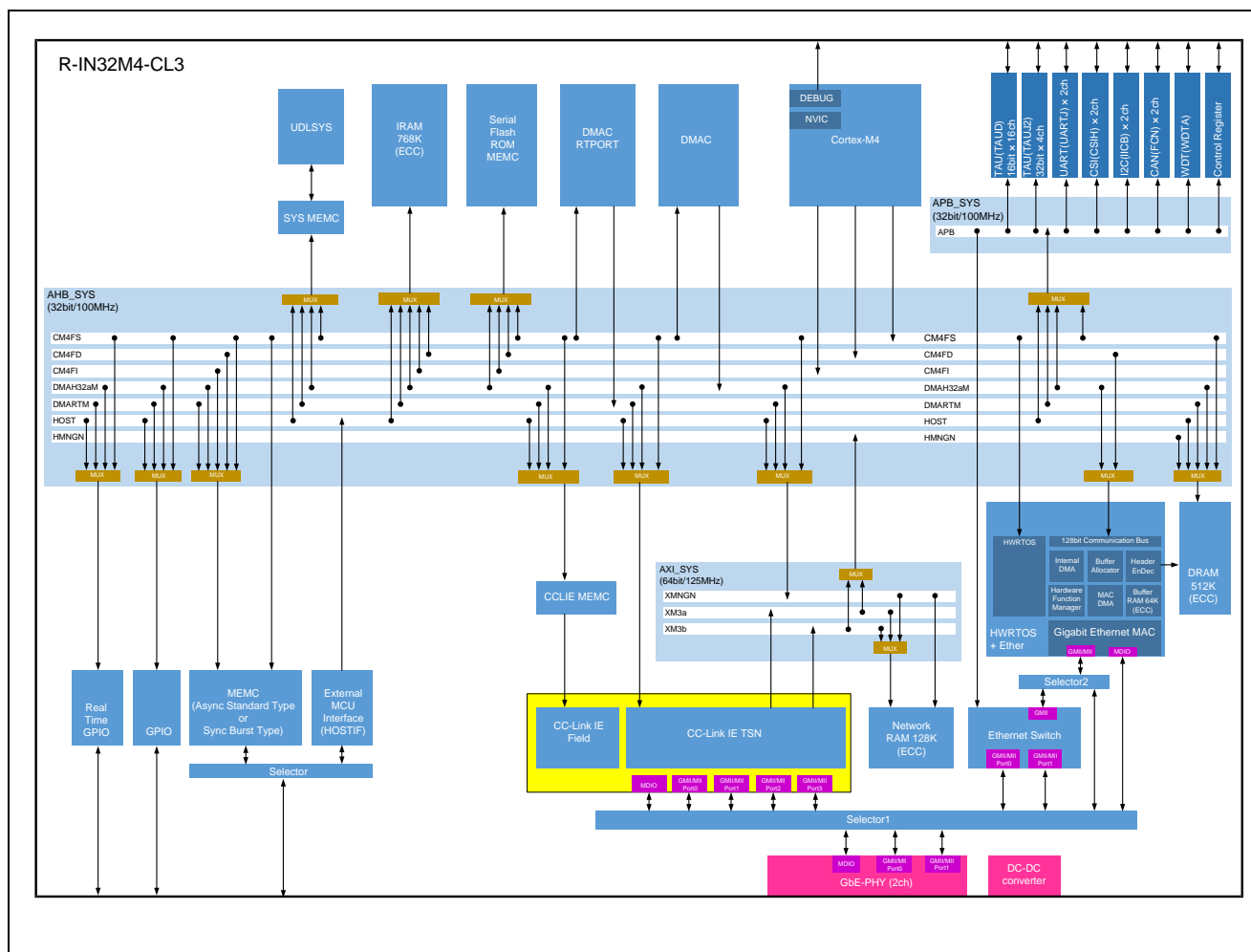
Table 1.1 Functional Overview of R-IN32M4-CL3 (3/3)

Item \ Product	R9A06G064MGBG (23 mm Square Package)	R9A06G064SGBG (17 mm Square Package)
On-chip debugging	<ul style="list-style-type: none"> • Selecting serial wire or JTAG • Full trace (built-in ETM) 	
Internal PLL	Generates various clocks from 25 MHz input clock	
Built-in regulator	2.5V power supply dedicated to PHY can be generated from 3.3V power supply	
Power supply voltage	$VDD33 = 3.3 \pm 0.165 \text{ V}^{*2}$ $VDD11 = 1.15 \pm 0.06 \text{ V}^{*2}$ $VDD25 = 2.5 \pm 0.125 \text{ V}^{*1, *2}$	
Operating temperature	$-40^{\circ}\text{C} \leq T_j \leq +125^{\circ}\text{C}$, $-40^{\circ}\text{C} \leq T_a \leq +85^{\circ}\text{C}$	
Packages	484-ball PBGA 23 mm × 23 mm, 1.0-mm Pitch	356-ball FBGA 17 mm × 17 mm, 0.8-mm Pitch

Note 1. 2.5 V power supply (VDD25) can be generated with the built-in regulator.

2. Ripple incorporated value. As a target value, set the DC component to within $\pm 3\%$ and the ripple component to within $\pm 2\%$.

1.2 Internal Block Diagram



1.3 Pin Assignments (Top View)

1.3.1 23 mm Square Package Pin Assignments (Top View)

	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V	W	Y	AA	AB	
22	GND	GND	RP21	RP23	RP25	RP27	RP02	RP00	GND/OPEN	GND/OPEN	GND/OPEN	P20	P22	P25	GND	P67	P65	P63	P60	P30	GND	GND	22
21	GND	RP20	RP22	RP24	RP26	RP04	RP03	RP01	GND/OPEN	GND/OPEN	GND/OPEN	P21	P23	P26	P27	P66	P64	P62	P61	P31	P32	GND	21
20	RP30	RP32	RP10	RP11	RP12	RP13	RP07	RP05	GND	VDD33	GND/OPEN	GND	P24	EXTP0	EXTP1	EXTP2	EXTP3	HWRZ SEL	HOT RESETZ	PONRZ	P33	RESETZ	20
19	RP31	RP33	RP37	RP14	RP15	RP16	RP17	RP06	GND	VDD33	GND/OPEN	GND	GND	TEST7	CLK2M SEL	VDD33	MEMC SEL	ADMUX MODE	BUS32 EN	RST OUTZ	P35	P34	19
18	BUS CLK	RP34	RP36	D15	GND	VDD33	GND	VDD33	GND	VDD33	VDD33	GND	GND	VDD11	GND	GND	VDD33	TEST6	MEMIF SEL	BOOT0	GND	CCL_CLK2_0 97M	18
17	D6	RP35	D13	D14	TEST3	VDD33	GND	VDD11	VDD11	VDD11	VDD11	VDD11	VDD11	VDD11	VDD11	GND	VDD33	PLL_VDD	HIF SYNC	BOOT1	P36	GND	17
16	D4	D5	D11	D12	GND	VDD33	GND	VDD11	GND	GND	GND	GND	GND	GND	VDD11	GND	VDD33	PLL_GND	EXTP9	EXTP8	P37	GND	16
15	D2	D3	D9	D10	GND	GND	GND	VDD11	GND	GND	GND	GND	GND	GND	VDD11	GND	GND	GND	EXTP7	EXTP6	P70	XT2	15
14	D0	D1	D7	D8	GND	VDD33	GND	VDD11	GND	GND	GND	GND	GND	GND	VDD11	GND	GND	GND	EXTP5	EXTP4	P71	XT1	14
13	RDZ	WRSTB Z	CSZ0	A20	GND	GND	GND	VDD11	VDD11	VDD11	VDD11	VDD11	VDD11	VDD11	VDD11	GND	VDD33	GND	OSCTH	NMIZ	P73	P72	13
12	P10	P12	WRZ0	A19	GND	VDD33	VDD33	GND	VDD33	GND	VDD33	VDD33	GND	VDD33	GND	VDD33	VDD33	GND	GND	TRACE CLK	P75	P74	12
11	P11	P13	WRZ1	A18	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	TRACE DATA1	TRACE DATA0	P77	P76	11
10	P14	P15	A17	GND	GND	GND	GND	GND	GND	GND	GND/OPEN	GND	GND	GND	GND	GND	GND	GND	GND	TRACE DATA2	P01	P00	10
9	P16	P17	A15	A16	GND	GND	GND	GND	VDD33	VDD33	VDD33	VDD33	VDD33	VDD33	GND	GND	GND	GND	TRSTZ	TRACE DATA3	P03	P02	9
8	P47	P44	A13	A14	GND	GND	GND	GND	VDD33	GND	GND	GND	GND	VDD33	GND	GND	GND	GND	TDO	JTAG SEL	P05	P04	8
7	P45	P46	A11	A12	GND	GND	GND	GND	VDD11	GND	GND	GND	GND	VDD11	GND	GND	GND	GND	TCK	TMODE 2	P07	P06	7
6	P43	P41	A9	A10	REG_EN	GND	AVDD REG_33	GND	VDD11	GND	GND	GND	GND	VDD11	GND	GND	GND	GND	TDI	TMODE 1	P51	P50	6
5	P42	A7	A8	PHY ADD1	AGND	GND	VDD REG_33	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	TMS	TMODE 0	P53	P52	5
4	P40	A5	A6	PHY ADD2	AGND	REG_OUT	GND	REG_FB	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	TEST5	TEST4	P55	P54	4
3	A2	A3	A4	PHY ADD3	GND	GND	GND	GND	GND	VDD11A	VDD11A	GND	VDD25A	VDD25A	VDD25A	GND	GND	GND	GND	GND	P57	P56	3
2	GND	PHY0_LED0	PHY ADD4	GND	GND	GND	P0_D3N	P0_D2N	P0_D1N	P0_D0N	GND	REF_FILT	GND	P1_D3N	P1_D2N	P1_D1N	P1_D0N	GND	GND	GND	PHY1_LED0	GND	2
1	GND	GND	GND	GND	GND	GND	P0_D3P	P0_D2P	P0_D1P	P0_D0P	GND	REF_REXT	GND	P1_D3P	P1_D2P	P1_D1P	P1_D0P	GND	GND	GND	GND	GND	1
	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V	W	Y	AA	AB	

Figure 1.1 23 mm Square Package Pin Assignments (Top View)

1.3.2 17 mm Square Package Pin Assignments (Top View)

	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V	W	Y	
20	GND	GND	GND	RP21	RP23	RP25	RP27	RP05	RP02	P24	P25	P27	P66	P64	P60	P30	PONRZ	GND	GND	GND	20
19	GND	RP37	RP20	RP22	RP24	RP26	RP04	RP03	RP01	P21	P26	P67	P65	P63	P61	P31	EXTP7	EXTP12	P32	GND	19
18	RP36	RP30	RP32	RP14	RP11	RP16	RP17	RP06	RP00	P22	EXTP0	EXTP1	EXTP2	P62	EXTP3	HOT RESETZ	EXTP13	BUS32 EN	P33	RESETZ	18
17	RP34	RP31	RP33	RP10	RP15	RP12	RP13	RP07	P20	P23	TEST7	CLK2M SEL	EXTP14	MEMC SEL	HWRZ SEL	ADMUX MODE	TEST6	MEMIF SEL	RST OUTZ	P34	17
16	BUS CLK	RP35	D14	D15													PLL_ VDD	BOOT0	P35	GND	16
15	D11	D12	D13	D10		GND	VDD33	VDD33	GND	GND	GND	VDD33	VDD33	GND	GND		PLL_ GND	BOOT1	P36	CC1_ CLK2_097M	15
14	D4	D5	D6	D9		GND	VDD11	GND	GND	VDD11	VDD11	GND	GND	VDD11	GND		EXTP9	HIF SYNC	P37	GND	14
13	D2	D3	D7	D8		GND	VDD11	GND	GND	GND	GND	GND	GND	VDD11	VDD33		EXTP8	EXTP6	P70	XT2	13
12	CSZ0	D0	D1	A20		VDD33	GND	GND	GND	GND	GND	GND	GND	GND	VDD33		EXTP5	EXTP4	P71	XT1	12
11	WRSTB Z	RDZ	WRZ0	A19		VDD33	VDD11	GND	GND	GND	GND	GND	GND	VDD11	GND		NMIZ	OSCTH	P73	P72	11
10	P15	P14	WRZ1	A18		GND	VDD11	GND	GND	GND	GND	GND	GND	VDD11	GND		GND	TRACE CLK	P75	P74	10
9	P16	P17	A17	A15		GND	VDD11	GND	GND	GND	GND	GND	GND	GND	GND		TRACE DATA1	TRACE DATA0	P77	P76	9
8	P47	P44	A13	A16		GND	VDD11	GND	GND	GND	GND	GND	GND	VDD11	VDD33		TRACE DATA3	TRACE DATA2	P01	P00	8
7	P45	P46	A14	A11		VDD33	GND	GND	VDD11	VDD11	GND	GND	GND	GND	VDD33		TRSTZ	EXTP10	P03	P02	7
6	P43	P41	A7	A12		REG_ EN	GND	GND	GND	GND	GND	GND	VDD11A	VDD11A	GND		TMODE 2	TDO	P05	P04	6
5	P42	P40	A9	A6													TCK	TMODE 1	JTAG SEL	EXTP11	5
4	A10	A8	A2	A3	GND	GND	GND	REG_ FB	GND	VDD25A	VDD25A	VDD25A	GND	GND	GND	TEST4	TEST5	TDI	P52	P50	4
3	A5	A4	GND	AGND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	TMODE 0	P57	P51	3
2	GND	PHY0_ LED0	REG_ OUT	AGND	GND	P0_D3N	P0_D2N	P0_D1N	P0_D0N	GND	REF_ FILT	GND	P1_D3N	P1_D2N	P1_D1N	P1_D0N	GND	PHY1_ LED0	TMS	GND	2
1	GND	GND	VDD REG_33	AVDD REG_33	GND	P0_D3P	P0_D2P	P0_D1P	P0_D0P	GND	REF_ REXT	GND	P1_D3P	P1_D2P	P1_D1P	P1_D0P	GND	GND	GND	GND	1
	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V	W	Y	

Figure 1.2 17 mm Square Package Pin Assignments (Top View)

1.4 External Pin List

1.4.1 23 mm Square Package

Table 1.2 23 mm Square Package External Pin List (1/4)

Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name
A1	GND	B15	D3	D7	A12	E21	RP26
A2	GND	B16	D5	D8	A14	E22	RP25
A3	A2	B17	RP35	D9	A16	F1	GND
A4	P40	B18	RP34	D10	GND	F2	GND
A5	P42	B19	RP33	D11	A18	F3	GND
A6	P43	B20	RP32	D12	A19	F4	REG_OUT
A7	P45	B21	RP20	D13	A20	F5	GND
A8	P47	B22	GND	D14	D8	F6	GND
A9	P16	C1	GND	D15	D10	F7	GND
A10	P14	C2	PHYADD4	D16	D12	F8	GND
A11	P11	C3	A4	D17	D14	F9	GND
A12	P10	C4	A6	D18	D15	F10	GND
A13	RDZ	C5	A8	D19	RP14	F11	GND
A14	D0	C6	A9	D20	RP11	F12	VDD33
A15	D2	C7	A11	D21	RP24	F13	GND
A16	D4	C8	A13	D22	RP23	F14	VDD33
A17	D6	C9	A15	E1	GND	F15	GND
A18	BUSCLK	C10	A17	E2	GND	F16	VDD33
A19	RP31	C11	WRZ1	E3	GND	F17	VDD33
A20	RP30	C12	WRZ0	E4	AGND	F18	VDD33
A21	GND	C13	CSZ0	E5	AGND	F19	RP16
A22	GND	C14	D7	E6	REG_EN	F20	RP13
B1	GND	C15	D9	E7	GND	F21	RP04
B2	PHY0_LED0	C16	D11	E8	GND	F22	RP27
B3	A3	C17	D13	E9	GND	G1	P0_D3P
B4	A5	C18	RP36	E10	GND	G2	P0_D3N
B5	A7	C19	RP37	E11	GND	G3	GND
B6	P41	C20	RP10	E12	GND	G4	GND
B7	P46	C21	RP22	E13	GND	G5	VDDREG_33
B8	P44	C22	RP21	E14	GND	G6	AVDDREG_33
B9	P17	D1	GND	E15	GND	G7	GND
B10	P15	D2	GND	E16	GND	G8	GND
B11	P13	D3	PHYADD3	E17	TEST3	G9	GND
B12	P12	D4	PHYADD2	E18	GND	G10	GND
B13	WRSTBZ	D5	PHYADD1	E19	RP15	G11	GND
B14	D1	D6	A10	E20	RP12	G12	VDD33

Table 1.2 23 mm Square Package External Pin List (2/4)

Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name
G13	GND	J9	VDD33	L5	GND	N1	GND
G14	GND	J10	GND	L6	GND	N2	GND
G15	GND	J11	GND	L7	GND	N3	VDD25A
G16	GND	J12	VDD33	L8	GND	N4	GND
G17	GND	J13	VDD11	L9	VDD33	N5	GND
G18	GND	J14	GND	L10	GND/OPEN	N6	GND
G19	RP17	J15	GND	L11	GND	N7	GND
G20	RP07	J16	GND	L12	VDD33	N8	GND
G21	RP03	J17	VDD11	L13	VDD11	N9	VDD33
G22	RP02	J18	GND	L14	GND	N10	GND
H1	P0_D2P	J19	GND	L15	GND	N11	GND
H2	P0_D2N	J20	GND	L16	GND	N12	GND
H3	GND	J21	GND/OPEN	L17	VDD11	N13	VDD11
H4	REG_FB	J22	GND/OPEN	L18	VDD33	N14	GND
H5	GND	K1	P0_D0P	L19	GND/OPEN	N15	GND
H6	GND	K2	P0_D0N	L20	GND/OPEN	N16	GND
H7	GND	K3	VDD11A	L21	GND/OPEN	N17	VDD11
H8	GND	K4	GND	L22	GND/OPEN	N18	GND
H9	GND	K5	GND	M1	REF_REXT	N19	GND
H10	GND	K6	GND	M2	REF_FILT	N20	P24
H11	GND	K7	GND	M3	GND	N21	P23
H12	GND	K8	GND	M4	GND	N22	P22
H13	VDD11	K9	VDD33	M5	GND	P1	P1_D3P
H14	VDD11	K10	GND	M6	GND	P2	P1_D3N
H15	VDD11	K11	GND	M7	GND	P3	VDD25A
H16	VDD11	K12	GND	M8	GND	P4	GND
H17	VDD11	K13	VDD11	M9	VDD33	P5	GND
H18	VDD33	K14	GND	M10	GND	P6	VDD11
H19	RP06	K15	GND	M11	GND	P7	VDD11
H20	RP05	K16	GND	M12	VDD33	P8	VDD33
H21	RP01	K17	VDD11	M13	VDD11	P9	VDD33
H22	RP00	K18	VDD33	M14	GND	P10	GND
J1	P0_D1P	K19	VDD33	M15	GND	P11	GND
J2	P0_D1N	K20	VDD33	M16	GND	P12	VDD33
J3	GND	K21	GND/OPEN	M17	VDD11	P13	VDD11
J4	GND	K22	GND/OPEN	M18	GND	P14	GND
J5	GND	L1	GND	M19	GND	P15	GND
J6	VDD11	L2	GND	M20	GND	P16	GND
J7	VDD11	L3	VDD11A	M21	P21	P17	VDD11
J8	VDD33	L4	GND	M22	P20	P18	VDD11

Table 1.2 23 mm Square Package External Pin List (3/4)

Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name
P19	TEST7	T15	GND	V11	GND	Y7	TMODE2
P20	EXTP0	T16	GND	V12	GND	Y8	JTAGSEL
P21	P26	T17	GND	V13	GND	Y9	TRACEDATA3
P22	P25	T18	GND	V14	GND	Y10	TRACEDATA2
R1	P1_D2P	T19	VDD33	V15	GND	Y11	TRACEDATA0
R2	P1_D2N	T20	EXTP2	V16	PLL_GND	Y12	TRACECLK
R3	VDD25A	T21	P66	V17	PLL_VDD	Y13	NMIZ
R4	GND	T22	P67	V18	TEST6	Y14	EXTP4
R5	GND	U1	P1_D0P	V19	ADMUXMODE	Y15	EXTP6
R6	GND	U2	P1_D0N	V20	HWRZSEL	Y16	EXTP8
R7	GND	U3	GND	V21	P62	Y17	BOOT1
R8	GND	U4	GND	V22	P63	Y18	BOOT0
R9	GND	U5	GND	W1	GND	Y19	RSTOUTZ
R10	GND	U6	GND	W2	GND	Y20	PONRZ
R11	GND	U7	GND	W3	GND	Y21	P31
R12	GND	U8	GND	W4	TEST5	Y22	P30
R13	VDD11	U9	GND	W5	TMS	AA1	GND
R14	VDD11	U10	GND	W6	TDI	AA2	PHY1_LED0
R15	VDD11	U11	GND	W7	TCK	AA3	P57
R16	VDD11	U12	VDD33	W8	TDO	AA4	P55
R17	VDD11	U13	VDD33	W9	TRSTZ	AA5	P53
R18	GND	U14	GND	W10	GND	AA6	P51
R19	CLK2MSEL	U15	GND	W11	TRACEDATA1	AA7	P07
R20	EXTP1	U16	VDD33	W12	GND	AA8	P05
R21	P27	U17	VDD33	W13	OSCTH	AA9	P03
R22	GND	U18	VDD33	W14	EXTP5	AA10	P01
T1	P1_D1P	U19	MEMCSEL	W15	EXTP7	AA11	P77
T2	P1_D1N	U20	EXTP3	W16	EXTP9	AA12	P75
T3	GND	U21	P64	W17	HIFSYNC	AA13	P73
T4	GND	U22	P65	W18	MEMIFSEL	AA14	P71
T5	GND	V1	GND	W19	BUS32EN	AA15	P70
T6	GND	V2	GND	W20	HOTRESETZ	AA16	P37
T7	GND	V3	GND	W21	P61	AA17	P36
T8	GND	V4	GND	W22	P60	AA18	GND
T9	GND	V5	GND	Y1	GND	AA19	P35
T10	GND	V6	GND	Y2	GND	AA20	P33
T11	GND	V7	GND	Y3	GND	AA21	P32
T12	VDD33	V8	GND	Y4	TEST4	AA22	GND
T13	GND	V9	GND	Y5	TMODE0	AB1	GND
T14	GND	V10	GND	Y6	TMODE1	AB2	GND

Table 1.2 23 mm Square Package External Pin List (4/4)

Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name
AB3	P56	AB8	P04	AB13	P72	AB18	CCI_CLK2 _097M
AB4	P54	AB9	P02	AB14	XT1	AB19	P34
AB5	P52	AB10	P00	AB15	XT2	AB20	RESETZ
AB6	P50	AB11	P76	AB16	GND	AB21	GND
AB7	P06	AB12	P74	AB17	GND	AB22	GND

1.4.2 17 mm Square Package

Table 1.3 17 mm Square Package External Pin List (1/3)

Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name
A1	GND	B19	RP37	D17	RP10	G10	VDD11
A2	GND	B20	GND	D18	RP14	G11	VDD11
A3	A5	C1	VDDREG_33	D19	RP22	G12	GND
A4	A10	C2	REG_OUT	D20	RP21	G13	VDD11
A5	P42	C3	GND	E1	GND	G14	VDD11
A6	P43	C4	A2	E2	GND	G15	VDD33
A7	P45	C5	A9	E3	GND	G17	RP13
A8	P47	C6	A7	E4	GND	G18	RP17
A9	P16	C7	A14	E17	RP15	G19	RP04
A10	P15	C8	A13	E18	RP11	G20	RP27
A11	WRSTBZ	C9	A17	E19	RP24	H1	P0_D1P
A12	CSZ0	C10	WRZ1	E20	RP23	H2	P0_D1N
A13	D2	C11	WRZ0	F1	P0_D3P	H3	GND
A14	D4	C12	D1	F2	P0_D3N	H4	REG_FB
A15	D11	C13	D7	F3	GND	H6	GND
A16	BUSCLK	C14	D6	F4	GND	H7	GND
A17	RP34	C15	D13	F6	REG_EN	H8	GND
A18	RP36	C16	D14	F7	VDD33	H9	GND
A19	GND	C17	RP33	F8	GND	H10	GND
A20	GND	C18	RP32	F9	GND	H11	GND
B1	GND	C19	RP20	F10	GND	H12	GND
B2	PHY0_LED0	C20	GND	F11	VDD33	H13	GND
B3	A4	D1	AVDDREG_33	F12	VDD33	H14	GND
B4	A8	D2	AGND	F13	GND	H15	VDD33
B5	P40	D3	AGND	F14	GND	H17	RP07
B6	P41	D4	A3	F15	GND	H18	RP06
B7	P46	D5	A6	F17	RP12	H19	RP03
B8	P44	D6	A12	F18	RP16	H20	RP05
B9	P17	D7	A11	F19	RP26	J1	P0_D0P
B10	P14	D8	A16	F20	RP25	J2	P0_D0N
B11	RDZ	D9	A15	G1	P0_D2P	J3	GND
B12	D0	D10	A18	G2	P0_D2N	J4	GND
B13	D3	D11	A19	G3	GND	J6	GND
B14	D5	D12	A20	G4	GND	J7	VDD11
B15	D12	D13	D8	G6	GND	J8	GND
B16	RP35	D14	D9	G7	GND	J9	GND
B17	RP31	D15	D10	G8	VDD11	J10	GND
B18	RP30	D16	D15	G9	VDD11	J11	GND

Table 1.3 17 mm Square Package External Pin List (2/3)

Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name
J12	GND	L17	TEST7	P1	P1_D2P	T17	ADMUXMODE
J13	GND	L18	EXTP0	P2	P1_D2N	T18	HOTRESETZ
J14	GND	L19	P26	P3	GND	T19	P31
J15	GND	L20	P25	P4	GND	T20	P30
J17	P20	M1	GND	P6	VDD11A	U1	GND
J18	RP00	M2	GND	P7	GND	U2	GND
J19	RP01	M3	GND	P8	VDD11	U3	GND
J20	RP02	M4	VDD25A	P9	GND	U4	TEST5
K1	GND	M6	GND	P10	VDD11	U5	TCK
K2	GND	M7	GND	P11	VDD11	U6	TMODE2
K3	GND	M8	GND	P12	GND	U7	TRSTZ
K4	VDD25A	M9	GND	P13	VDD11	U8	TRACEDATA3
K6	GND	M10	GND	P14	VDD11	U9	TRACEDATA1
K7	VDD11	M11	GND	P15	GND	U10	GND
K8	GND	M12	GND	P17	MEMCSEL	U11	NMIZ
K9	GND	M13	GND	P18	P62	U12	EXTP5
K10	GND	M14	GND	P19	P63	U13	EXTP8
K11	GND	M15	VDD33	P20	P64	U14	EXTP9
K12	GND	M17	CLK2MSEL	R1	P1_D1P	U15	PLL_GND
K13	GND	M18	EXTP1	R2	P1_D1N	U16	PLL_VDD
K14	VDD11	M19	P67	R3	GND	U17	TEST6
K15	GND	M20	P27	R4	GND	U18	EXTP13
K17	P23	N1	P1_D3P	R6	GND	U19	EXTP7
K18	P22	N2	P1_D3N	R7	VDD33	U20	PONRZ
K19	P21	N3	GND	R8	VDD33	V1	GND
K20	P24	N4	GND	R9	GND	V2	PHY1_LED0
L1	REF_REXT	N6	VDD11A	R10	GND	V3	TMODE0
L2	REF_FILT	N7	GND	R11	GND	V4	TDI
L3	GND	N8	GND	R12	VDD33	V5	TMODE1
L4	VDD25A	N9	GND	R13	VDD33	V6	TDO
L6	GND	N10	GND	R14	GND	V7	EXTP10
L7	GND	N11	GND	R15	GND	V8	TRACEDATA2
L8	GND	N12	GND	R17	HWRZSEL	V9	TRACEDATA0
L9	GND	N13	GND	R18	EXTP3	V10	TRACECLK
L10	GND	N14	GND	R19	P61	V11	OSCTH
L11	GND	N15	VDD33	R20	P60	V12	EXTP4
L12	GND	N17	EXTP14	T1	P1_D0P	V13	EXTP6
L13	GND	N18	EXTP2	T2	P1_D0N	V14	HIFSYNC
L14	VDD11	N19	P65	T3	GND	V15	BOOT1
L15	GND	N20	P66	T4	TEST4	V16	BOOT0

Table 1.3 17 mm Square Package External Pin List (3/3)

Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name	Pin ID	Pin Name
V17	MEMIFSEL	W8	P01	W19	P32	Y10	P74
V18	BUS32EN	W9	P77	W20	GND	Y11	P72
V19	EXTP12	W10	P75	Y1	GND	Y12	XT1
V20	GND	W11	P73	Y2	GND	Y13	XT2
W1	GND	W12	P71	Y3	P51	Y14	GND
W2	TMS	W13	P70	Y4	P50	Y15	CCI_CLK2_097M
W3	P57	W14	P37	Y5	EXTP11	Y16	GND
W4	P52	W15	P36	Y6	P04	Y17	P34
W5	JTAGSEL	W16	P35	Y7	P02	Y18	RESETZ
W6	P05	W17	RSTOUTZ	Y8	P00	Y19	GND
W7	P03	W18	P33	Y9	P76	Y20	GND

2. Pin List by Function

The following tables list the meanings of the items, symbols, and abbreviations used in each pin table in this chapter. Some pins and functions are not available depending on the type of package. Refer to the PKG column.

Table 2.1 Meanings of the Items in the Pin Lists

Item	Meaning
Function Name	Name of a function of the pin under "Pin Name" below.
Pin Name	Name of the pin shown in Section 1.3 "Pin Assignments (Top View)".
PKG	Type of package 23□: 23 mm Square Package 17□: 17 mm Square Package
I/O	I/O direction of the given pin
Description	Summary of the given pin function
Active	Active level of the given pin
Level during Reset	The pin state while RSTOUTZ is Low. For details on the reset specifications, refer to the "R-IN32M4-CL3 User's Manual: Hardware edition".

Table 2.2 Meanings of the Symbols and Abbreviations in the Pin Lists

Target	Symbol and Abbreviation	Meaning
Pin Name	— (hyphen)	The pin is a dedicated pin that is not multiplexed with a port-pin function.
PKG	○	The pin exists.
	×	The pin does not exist.
I/O	— (hyphen)	The pin does not have an I/O direction, such as a power supply or ground pin.
Active	— (hyphen)	There is no active level (clock pins, data pins, and address pins).
	High	The active level is high.
	Low	The active level is low.
Level during Reset	— (hyphen)	This is an input-dedicated pin that has no initial level or state following a reset.
	High	The pin state during a reset is high.
	Low	The pin state during a reset is low.
	Hi-Z (High)	The pin state during a reset is Hi-Z (high) with the internal pull-up resistor pulling it to the high level.
	Hi-Z (Low)	The pin state during a reset is Hi-Z (Low) with the internal pull-down resistor pulling it to the Low level.

The pins described in Section 2.2 "Ethernet Pins" to Section 2.15 "Operating Mode Setting Pins" are multiplexed with port pins described in Section 2.1 "Port Pins and Real-Time Port Pins". For details, refer to Multiplexed function 1 to Multiplexed function 4 in Section 2.1 "Port Pins and Real-Time Port Pins".

2.1 Port Pins and Real-Time Port Pins

The LSI has 13 ports for the 3.3 V interface, all of which are 8-bit ports except for EXTP, which has 15 bits.

Grouping them into sets of four ports allows 32-bit access: for example, through ports 0 to 3 (P00–P37), ports 4 to 7 (P40–P77), and real-time ports 0 to 3 (RP00–RP37).

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Pin Name	PKG		Multiplexed Function 1	Multiplexed Function 2	Multiplexed Function 3	Multiplexed Function 4	Level during Reset
	23□	17□					
P00	○	○	INTPZ0	—	CCI_RUNLEDZ	—	Hi-Z (High)
P01	○	○	INTPZ1	—	—	—	
P02	○	○	INTPZ2	—	CCI_DLINKLEDZ	—	
P03	○	○	INTPZ3	—	CCI_ERRLEDZ	—	
P04	○	○	INTPZ4	—	CCI_LERR1LEDZ	—	
P05	○	○	INTPZ5	—	CCI_LERR2LEDZ	—	
P06	○	×	—	—	CCI_SDLEDZ	—	
P07	○	×	—	—	CCI_RDLEDZ	—	
P10	○	×	SMIO2	—	—	—	
P11	○	×	SMIO3	—	—	—	
P12	○	×	CSZ3	—	CCI_WDTIZ	—	
P13	○	×	CSZ2	—	—	—	
P14	○	○	SMSCK	—	—	—	
P15	○	○	SMIO0	—	—	—	
P16	○	○	SMIO1	—	—	—	
P17	○	○	SMCSZ	—	—	—	
P20	○	○	RXD0	—	—	—	
P21	○	○	TXD0	—	—	—	
P22	○	○	INTPZ8	—	—	—	
P23	○	○	INTPZ9	—	—	—	
P24	○	○	INTPZ10	ETHSWSYNCOU	—	—	
P25	○	○	WDTOUTZ	—	—	—	
P26	○	○	TINJ1 / TIND5*1	TOUTJ1 / TOUTD5*1	—	—	
P27	○	○	TINJ0 / TIND4*1	TOUTJ0 / TOUTD4*1	—	—	

Note 1. Enabling the TAUJ2 or TAUD pin function is selectable by using the TMISEL register.
For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

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Pin Name	PKG		Multiplexed Function 1	Multiplexed Function 2	Multiplexed Function 3	Multiplexed Function 4	Level during Reset
	23□	17□					
P30	○	○	RXD1	—	—	—	Hi-Z (High)
P31	○	○	TXD1	—	—	—	
P32	○	○	DMAREQZ1	—	—	—	
P33	○	○	DMAACKZ1	—	—	—	
P34	○	○	DMATCZ1	—	—	—	
P35	○	○	CSISCK1	INTPZ22	—	—	Hi-Z (Low)
P36	○	○	CSISI1	INTPZ23	—	—	Hi-Z (High)
P37	○	○	CSISO1	INTPZ24	—	—	Hi-Z (Low)
P40	○	○	A1 / MA0	HA1	—	—	Hi-Z (High)
P41	○	○	WAITZ	HWAITZ	INTPZ29	—	
P42	○	○	CSICS00	HERROUTZ	—	—	
P43	○	○	CSICS01	HBUSCLK	—	—	
P44	○	○	CSZ1	HPGCSZ	—	—	
P45	○	○	CSISCK0	WAITZ1	—	—	
P46	○	○	CSISI0	WAITZ2	—	—	
P47	○	○	CSISO0	WAITZ3	—	—	
P50	○	○	INTPZ6	—	—	—	
P51	○	○	INTPZ7	—	—	—	
P52	○	○	TINJ3 / TIND7*1	TOUTJ3 / TOUTD7*1	CCI_NMIZ	—	Hi-Z (High)
P53	○	×	CRXD0	CCI_INTZ	—	—	
P54	○	×	CTXD0	—	—	—	
P55	○	×	CRXD1	—	—	—	
P56	○	×	CTXD1	—	—	—	
P57	○	○	TINJ2 / TIND6*1	TOUTJ2 / TOUTD6*1	—	—	

Note 1. Enabling the TAUJ2 or TAUD pin function is selectable by using the TMISEL register.
For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

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Pin Name	PKG		Multiplexed Function 1	Multiplexed Function 2	Multiplexed Function 3	Multiplexed Function 4	Level during Reset
	23□	17□					
P60	○	○	SCL0	—	—	—	Hi-Z (High)
P61	○	○	SDA0	—	—	—	
P62	○	○	RTDMAREQZ	—	—	—	
P63	○	○	RTDMAACKZ	—	—	—	
P64	○	○	RTDMATCZ	—	—	—	
P65	○	○	DMAREQZ0	—	—	—	
P66	○	○	DMAACKZ0	—	—	—	
P67	○	○	DMATCZ0	—	—	—	
P70	○	○	CSICS10	—	—	—	
P71	○	○	CSICS11	—	—	—	
P72	○	○	SLEEPING	—	—	—	
P73	○	○	INTPZ11	—	—	—	
P74	○	○	INTPZ12	—	—	—	
P75	○	○	INTPZ13	—	—	—	
P76	○	○	INTPZ14	—	—	—	
P77	○	○	INTPZ15	—	—	—	

(4/5)

Pin Name	PKG		Multiplexed Function 1	Multiplexed Function 2	Multiplexed Function 3	Multiplexed Function 4	Level during Reset
	23□	17□					
EXTP0	○	○	—	TOUTD0	—	TIND0	Hi-Z (High)
EXTP1	○	○	—	TOUTD1	—	TIND1	
EXTP2	○	○	—	TOUTD2	—	TIND2	
EXTP3	○	○	WDTOUTZ	TOUTD3	—	TIND3	
EXTP4	○	○	—	—	—	—	
EXTP5	○	○	—	—	—	—	Hi-Z (Low)
EXTP6	○	○	—	—	—	—	
EXTP7	○	○	—	—	—	—	Hi-Z (High)
EXTP8	○	○	—	—	—	—	
EXTP9	○	○	—	—	—	—	
EXTP10	×	○	SMIO2	CCI_INTZ	—	—	
EXTP11	×	○	SMIO3	CCI_WDTIZ	—	—	
EXTP12	×	○	CSZ3	CCI_SDLEDZ	—	—	
EXTP13	×	○	CSZ2	CCI_RDLEDZ	—	—	
EXTP14	×	○	IETYPE_LED	—	—	—	

Ports RP0x to RP3x (x: 0–7) operate as real-time ports. These ports can handle input and output in 32-bit units in synchronization with the DMA transfer trigger from the dedicated DMA controller for the real-time ports.

(5/5)

Pin Name	PKG		Multiplexed Function 1	Multiplexed Function 2	Multiplexed Function 3	Multiplexed Function 4	Level during Reset
	23□	17□					
RP00	○	○	INTPZ16	SCL1	—	—	Hi-Z (High)
RP01	○	○	INTPZ17	SDA1	—	—	
RP02	○	○	INTPZ18	—	—	—	
RP03	○	○	INTPZ19	—	—	—	
RP04	○	○	INTPZ20	—	—	—	
RP05	○	○	INTPZ21	—	—	—	
RP06	○	○	WRZ2 / BENZ2	HWRZ2 / HBENZ2	—	—	
RP07	○	○	WRZ3 / BENZ3	HWRZ3 / HBENZ3	—	—	
RP10	○	○	D24 / MD24 / HD24	LED0_PHY0	—	—	
RP11	○	○	D25 / MD25 / HD25	LED1_PHY0	—	—	
RP12	○	○	D26 / MD26 / HD26	LED2_PHY0	—	—	
RP13	○	○	D27 / MD27 / HD27	LED3_PHY0	—	—	
RP14	○	○	D28 / MD28 / HD28	LED0_PHY1	—	—	
RP15	○	○	D29 / MD29 / HD29	LED1_PHY1	—	—	
RP16	○	○	D30 / MD30 / HD30	LED2_PHY1	—	—	
RP17	○	○	D31 / MD31 / HD31	LED3_PHY1	—	—	
RP20	○	○	BCYSTZ / ADVZ	HBCYSTZ	—	—	
RP21	○	×	A21 / MA20	—	—	—	Hi-Z (Low)
	×	○					Hi-Z (High)
RP22	○	×	A22 / MA21	—	—	—	Hi-Z (Low)
	×	○					Hi-Z (High)
RP23	○	×	A23 / MA22	—	—	—	Hi-Z (Low)
	×	○					Hi-Z (High)
RP24	○	×	A24 / MA23	INTPZ25	—	—	Hi-Z (Low)
	×	○					Hi-Z (High)
RP25	○	×	A25 / MA24	INTPZ26	—	—	Hi-Z (Low)
	×	○					Hi-Z (High)
RP26	○	×	A26 / MA25	INTPZ27	—	—	Hi-Z (Low)
	×	○					Hi-Z (High)
RP27	○	×	A27 / MA26	INTPZ28	—	—	Hi-Z (Low)
	×	○					Hi-Z (High)
RP30	○	○	D16 / MD16 / HD16	TOUTD8	TIND8	—	
RP31	○	○	D17 / MD17 / HD17	TOUTD9	TIND9	—	
RP32	○	○	D18 / MD18 / HD18	TOUTD10	TIND10	—	
RP33	○	○	D19 / MD19 / HD19	TOUTD11	TIND11	—	
RP34	○	○	D20 / MD20 / HD20	TOUTD12	TIND12	—	
RP35	○	○	D21 / MD21 / HD21	TOUTD13	TIND13	—	
RP36	○	○	D22 / MD22 / HD22	TOUTD14	TIND14	—	
RP37	○	○	D23 / MD23 / HD23	TOUTD15	TIND15	—	

2.2 Ethernet Pins

(1/2)

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
P0_D0N	—	○	○	I/O	PHY 0 Tx/Rx channel A negative signal	—	—
P0_D0P	—	○	○		PHY 0 Tx/Rx channel A positive signal		
P0_D1N	—	○	○		PHY 0 Tx/Rx channel B negative signal		
P0_D1P	—	○	○		PHY 0 Tx/Rx channel B positive signal		
P0_D2N	—	○	○		PHY 0 Tx/Rx channel C negative signal		
P0_D2P	—	○	○		PHY 0 Tx/Rx channel C positive signal		
P0_D3N	—	○	○		PHY 0 Tx/Rx channel D negative signal		
P0_D3P	—	○	○		PHY 0 Tx/Rx channel D positive signal		
P1_D0N	—	○	○		PHY 1 Tx/Rx channel A negative signal		
P1_D0P	—	○	○		PHY 1 Tx/Rx channel A positive signal		
P1_D1N	—	○	○		PHY 1 Tx/Rx channel B negative signal		
P1_D1P	—	○	○		PHY 1 Tx/Rx channel B positive signal		
P1_D2N	—	○	○		PHY 1 Tx/Rx channel C negative signal		
P1_D2P	—	○	○		PHY 1 Tx/Rx channel C positive signal		
P1_D3N	—	○	○		PHY 1 Tx/Rx channel D negative signal		
P1_D3P	—	○	○		PHY 1 Tx/Rx channel D positive signal		
PHYADD1	—	○	×	I	Device SMI Address bit 1 (with Pull-Down resistance)	Low	High
PHYADD2	—	○	×		Device SMI Address bit 2 (with Pull-Down resistance)		
PHYADD3	—	○	×		Device SMI Address bit 3 (with Pull-Down resistance)		
PHYADD4	—	○	×		Device SMI Address bit 4 (with Pull-Down resistance)		
REF_FILT	—	○	○	I/O	Copper media reference filter pin.		
REF_REXT	—	○	○		Copper media reference external pin.		
VDD11A	—	○	○	—	1.15 V analog power requiring additional PCB power supply filtering		
VDD25A	—	○	○		2.5 V general analog power supply		
PHY0_LED0	—	○	○	O	GbE-PHY LED0_PHY0 output signal		Hi-Z (High)
PHY1_LED0	—	○	○		GbE-PHY LED0_PHY1 output signal		
LED0_PHY0	RP10	○	○		GbE-PHY LED signal output (Same signal as external pin PHY0_LED0)		
LED1_PHY0	RP11	○	○		GbE-PHY LED signal output		
LED2_PHY0	RP12	○	○		GbE-PHY LED signal output		
LED3_PHY0	RP13	○	○		GbE-PHY LED signal output		
LED0_PHY1	RP14	○	○		GbE-PHY LED signal output (Same signal as external pin PHY1_LED0)		
LED1_PHY1	RP15	○	○		GbE-PHY LED signal output		
LED2_PHY1	RP16	○	○		GbE-PHY LED signal output		
LED3_PHY1	RP17	○	○		GbE-PHY LED signal output		
ETHSWSYNCOUT	P24	○	○		Ethernet switch event output	High	

(2/2)

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
VDDREG_33	—	○	○	—	3.3 V power for 2.5 V regulator	—	—
AVDDREG_33	—	○	○		3.3 V analog power for 2.5 V regulator		
REG_EN	—	○	○	I	2.5 V Regulator enable		
REG_FB	—	○	○		Feedback from the supply regulation point		
AGND	—	○	○	—	Analog ground for regulator		
REG_OUT*1	—	○	○	O	2.5 V Regulator output		

Note 1. The power supply of 2.5 V via the REG_OUT pin is dedicated to the VDD25A.
The pin is not available for the power supply of 2.5 V to other devices.

2.3 External SRAM and External MCU Interface Pins

Usage of the external SRAM interface pins and external MCU interface pins is exclusive.

This setting is selected by the level of the MEMIFSEL pin. (Setting value: Low level for the external SRAM interface pins and High level for the external MCU interface pins)

2.3.1 External SRAM Interface Pins

(a) External SRAM Interface Pins (when Asynchronous SRAM Controller is Selected (MEMCSEL = 0))

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
BUSCLK	—	○	○	O	Bus clock output	—	Clock output
CSZ0	—	○	○		Chip select signal output	Low	Hi-Z (High)
CSZ1	P44	○	○				
CSZ2	P13	○	×				
	EXTP13	×	○				
CSZ3	P12	○	×				
	EXTP12	×	○				
A1	P40	○	○		Address output	—	Hi-Z (Low)
A2–A20	—	○	○				
A21–A27	RP21–RP27	○	○				
D0–D15	—	○	○	I/O	Data bus		Hi-Z (Low)
D16–D31	RP30–RP37, RP10–RP17	○	○				Hi-Z (High)
RDZ	—	○	○	O	Read strobe output	Low	
WRSTBZ	—	○	○		Write strobe output		
WRZ0 / BENZ0*1	WRZ0	○	○		Valid byte lane strobe output		
WRZ1 / BENZ1*1	WRZ1	○	○				
WRZ2 / BENZ2*1	RP06	○	○				
WRZ3 / BENZ3*1	RP07	○	○				
WAITZ	P41	○	○	I	Wait signal input		
BCYSTZ	RP20	○	○	O	Bus cycle start status output		

Remark. The external memory interface pins other than BUSCLK are inputs as long as the internal reset signal (HRESETZ) is active.

Note 1. The WREN register is used to switch the pin functions between WRZ3–WRZ0 and BENZ3–BENZ0. For details on this register, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

(b) External SRAM Interface Pins (When Synchronous Burst Access Memory Controller is Selected (MEMCSEL = 1))

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
BUSCLK	—	○	○	O	Bus clock output	—	Low
CSZ0	—	○	○		Chip select signal output	Low	Hi-Z (High)
CSZ1	P44	○	○				
CSZ2	P13	○	×				
	EXTP13	×	○				
CSZ3	P12	○	×				
	EXTP12	×	○				
MA0	P40	○	○		Address output	—	
MA1–MA19	A2–A20	○	○	Hi-Z (Low)			
MA20–MA26	RP21–RP27	○	○	Hi-Z (High)			
MD0–MD15 / MA0–MA15*1	D0–D15	○	○	I/O	Data bus		Hi-Z (Low)
MD16–MD31 / MA16–MA31*1	RP30–RP37, RP10–RP17	○	○				Hi-Z (High)
RDZ	—	○	○	O	Read strobe output	Low	
WRSTBZ	—	○	○		Write strobe output		
WRZ0 / BENZ0*2	WRZ0	○	○		Valid byte lane strobe output		
WRZ1 / BENZ1*2	WRZ1	○	○				
WRZ2 / BENZ2*2	RP06	○	○				
WRZ3 / BENZ3*2	RP07	○	○				
WAITZ	P41	○	○	I	Wait signal input		
WAITZ1–WAITZ3	P45–P47	○	○				
ADVZ	RP20	○	○	O	Address valid output		

Remark. The external memory interface pins other than BUSCLK are inputs as long as the internal reset signal (HRESETZ) is active.

Note 1. When the ADMUXMODE pin is at the High level, these pin functions are multiplexed with address pin functions.

ADMUXMODE = 0: MD0–MD31 (separated address and data lines)

ADMUXMODE = 1: MD0–MD31 / MA0 to MA31 (multiplexed address and data lines)

2. The SET_OPMODE register is used to the switch pin functions between WRZ3–WRZ0 and BENZ3–BENZ0.

For details on this register, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

2.3.2 External MCU Interface Pins

(a) External MCU Interface Pins (When Asynchronous SRAM Memory Controller is Selected (MEMCSEL = 0))

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
HBUSCLK* ¹	P43	○	○	I	Bus clock input	—	Hi-Z (High)
HCSZ	CSZ0	○	○		Chip select signal input	Low	
HPGCSZ	P44	○	○		Page ROM mode chip select signal input		
HWAITZ	P41	○	○	O	Wait signal output	—	Hi-Z (Low)
HA1	P40	○	○	I	Address signal input		
HA2–HA20	A2–A20	○	○				
HD0–HD15	D0–D15	○	○	I/O	Data bus		Hi-Z (High)
HD16–HD31	RP30–RP37, RP10–RP17	○	○				
HRDZ	RDZ	○	○	I	Read strobe input	Low	
HWRSTBZ	WRSTBZ	○	○		Write strobe input		
HWRZ0 / HBENZ0* ²	WRZ0	○	○		Valid byte lane strobe input		
HWRZ1 / HBENZ1* ²	WRZ1	○	○				
HWRZ2 / HBENZ2* ²	RP06	○	○				
HWRZ3 / HBENZ3* ²	RP07	○	○				
HERROUTZ	P42	○	○	O	Error interrupt output		High
HBCYSTZ	RP20	○	○	I	Bus cycle input		Hi-Z (High)

Note 1. The HBUSCLK pin is used only in case of synchronous SRAM supported MCU connection mode (HIFSYNC pin is High). The HBUSCLK pin is not used in case of asynchronous SRAM supported MCU connection mode (HIFSYNC pin is Low). Furthermore, the other signal connection is common in each mode.

For details on the connection example, refer to the "R-IN32M4-CL3 User's Manual: Board Design edition".

2. The level being input on the HWRZSEL pin controls switching between HWRZ3–HWRZ0 and HBENZ3–HBENZ0 signals.

Remark. The external MCU interface pins continue to operate as those pins even during a reset.

(b) External MCU Interface Pins (When Synchronous Burst Access Memory Controller is Selected (MEMCSEL = 1))

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
HBUSCLK	P43	○	○	I	Bus clock input	—	Hi-Z (High)
HCSZ	CSZ0	○	○		Chip select signal input	Low	
HPGCSZ	P44	○	○		Page ROM mode chip select signal input		
HWAITZ	P41	○	○	O	Wait signal output	—	
HA1*1	P40	○	○	I	Address signal input		
HA2–HA20*1	A2–A20	○	○				
HD0–HD15*1	D0–D15	○	○	I/O	Data bus		Hi-Z (Low)
HD16–HD31*1	RP30–RP37, RP10–RP17	○	○				
HRDZ	RDZ	○	○	I	Read strobe input	Low	Hi-Z (High)
HWRSTBZ	WRSTBZ	○	○		Write strobe input		
HWRZ0 / HBENZ0*2	WRZ0	○	○		Valid byte lane strobe input		
HWRZ1 / HBENZ1*2	WRZ1	○	○				
HWRZ2 / HBENZ2*2	RP06	○	○				
HWRZ3 / HBENZ3*2	RP07	○	○				
HERROUTZ	P42	○	○	O	Error interrupt output	High	
HBCYSTZ	RP20	○	○	I	Bus cycle input		Hi-Z (High)

Note 1. The address/data pin connection depends on address/data multiplex mode (ADMUXMODE pin is High) or address/data separate mode (ADMUXMODE pin is Low).

For details on the connection example, refer to the “R-IN32M4-CL3 User's Manual: Board Design edition”.

2. When the MEMCSEL pin is High, setting the HWRZSEL pin to High is prohibited.

Remark. The external MCU interface pins continue to operate as those pins even during a reset.

2.4 Serial Flash ROM Interface Pins

The serial flash ROM interface pins are the pins of the serial flash ROM controller.

These pins support the following instruction formats: Fast Read, Fast Read Dual Output, Fast Read Dual I/O, Fast Read Quad Output, and Fast Read Quad I/O.

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
SMSCK	P14	○	○	O	Serial clock output signal for serial flash ROM	—	Hi-Z (High)
SMIO0	P15	○	○	I/O	Serial data I/O signals for serial flash ROM (Connected to the IO0 pin of serial flash ROM)		
SMIO1	P16	○	○		Serial data I/O signals for serial flash ROM (Connected to the IO1 pin of serial flash ROM)		
SMIO2	P10	○	×		Serial data I/O signals for serial flash ROM (Connected to the /WP(IO2) pin of serial flash ROM)		
	EXTP10	×	○				
SMIO3	P11	○	×		Serial data I/O signals for serial flash ROM (Connected to the /HOLD(IO3) pin of serial flash ROM)		
	EXTP11	×	○				
SMCSZ	P17	○	○	O	Chip select output signal for serial flash ROM	Low	

2.5 DMA Interface Pins

The DMA interface pins are the external interface pins of the DMA controllers.

Two types of DMA controllers built into the R-IN32M4-CL3, general-purpose DMA controllers (channels 0 and 1) and real-time port DMA controller, can be used as external DMA interfaces.

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
RTDMAREQZ	P62	○	○	I	RTDMAC DMA transfer request input	Low	Hi-Z (High)
RTDMAACKZ	P63	○	○	O	RTDMAC DMA acknowledge output		
RTDMATCZ	P64	○	○		RTDMAC terminal count output		
DMAREQZ0	P65	○	○	I	DMA transfer request input 0		
DMAACKZ0	P66	○	○	O	DMA acknowledge output 0		
DMATCZ0	P67	○	○		Terminal count output 0		
DMAREQZ1	P32	○	○	I	DMA transfer request input 1		
DMAACKZ1	P33	○	○	O	DMA acknowledge output 1		
DMATCZ1	P34	○	○		Terminal count output 1		

Note. These pins are fixed to channels of the DMA controllers. The pins cannot be assigned to the desired channel. For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

2.6 External Interrupt Input Pins

The LSI has one non-maskable interrupt and 30 maskable interrupt input pins.

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
NMIZ	—	○	○	I	Non-maskable external interrupt input	Low	Hi-Z (High)
INTPZ0–INTPZ5	P00–P05	○	○	I	External interrupt input		
INTPZ6	P50	○	○				
INTPZ7	P51	○	○				
INTPZ8–INTPZ10	P22–P24	○	○				
INTPZ11–INTPZ15	P73–P77	○	○				
INTPZ16–INTPZ21	RP00–RP05	○	○				
INTPZ22	P35	○	○				
INTPZ23	P36	○	○				
INTPZ24	P37	○	○				
INTPZ25–INTPZ28	RP24–RP27	○	○				
INTPZ29	P41	○	○				

2.7 Timer I/O Pins

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset		
		23□	17□						
TINJ0 / TOUTJ0*1	P27	○	○	I/O	Timer TAUJ2 I/O pin	—	Hi-Z (High)		
TINJ1 / TOUTJ1*1	P26	○	○						
TINJ2 / TOUTJ2*1	P57	○	○						
TINJ3 / TOUTJ3*1	P52	○	○						
TIND0 / TOUTD0	EXTP0	○	○		Timer TAUD I/O pin				
TIND1 / TOUTD1	EXTP1	○	○						
TIND2 / TOUTD2	EXTP2	○	○						
TIND3 / TOUTD3	EXTP3	○	○						
TIND4 / TOUTD4*1	P27	○	○						
TIND5 / TOUTD5*1	P26	○	○						
TIND6 / TOUTD6*1	P57	○	○						
TIND7 / TOUTD7*1	P52	○	○						
TIND8 / TOUTD8	RP30	○	○						
TIND9 / TOUTD9	RP31	○	○						
TIND10 / TOUTD10	RP32	○	○						
TIND11 / TOUTD11	RP33	○	○						
TIND12 / TOUTD12	RP34	○	○						
TIND13 / TOUTD13	RP35	○	○						
TIND14 / TOUTD14	RP36	○	○						
TIND15 / TOUTD15	RP37	○	○						

Note 1. TINJ0–TINJ3 and TIND4–TIND7, and TOUTJ0–TOUTJ3 and TOUTD4–TOUTD7 are assigned as multiplexed functions of the same port pins. Use the TMISSEL register to select the pin functions to be used.

For details on this register, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

When the external pin functions such as the interval timer function of the internal clock are not used, both TAUJ2 and TAUD channels can be used at the same time.

2.8 Watchdog Timer Output Pin

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
WDTOUTZ	P25 / EXTP3	○	○	O	Watchdog timer output pin	Low	Hi-Z (High)

2.9 Serial Interface Pins

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
TXD0	P21	○	○	O	UART0 serial data output	—	Hi-Z (High)
RXD0	P20	○	○	I	UART0 serial data input		
TXD1	P31	○	○	O	UART1 serial data output		
RXD1	P30	○	○	I	UART1 serial data input		
CSISCK0	P45	○	○	I/O	CSI0 serial clock input/output		
CSISI0	P46	○	○	I	CSI0 serial data input		
CSISO0	P47	○	○	O	CSI0 serial data output		
CSICS00	P42	○	○		CSI0 chip select signal output 0	Low	
CSICS01	P43	○	○		CSI0 chip select signal output 1		
CSISCK1	P35	○	○	I/O	CSI1 serial clock input/output	—	Hi-Z (Low)
CSISI1	P36	○	○	I	CSI1 serial data input		Hi-Z (High)
CSISO1	P37	○	○	O	CSI1 serial data output		Hi-Z (Low)
CSICS10	P70	○	○		CSI1 chip select signal output 0	Low	Hi-Z (High)
CSICS11	P71	○	○		CSI1 chip select signal output 1		
SCL0*1	P60	○	○	I/O	I ² C0 serial clock	—	
SDA0*1	P61	○	○		I ² C0 serial data		
SCL1*1	RP00	○	○		I ² C1 serial clock		
SDA1*1	RP01	○	○		I ² C1 serial data		
CRXD0	P53	○	×	I	CAN0 receive data input (5 V tolerant)		
CTXD0	P54	○	×	O	CAN0 transmit data output (5 V tolerant)		
CRXD1	P55	○	×	I	CAN1 receive data input (5 V tolerant)		
CTXD1	P56	○	×	O	CAN1 transmit data output (5 V tolerant)		

Note 1. The SCLn and SDAn pins (n = 0, 1) are open-drain outputs.

For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

2.10 CC-Link IE Pins

These pins are used for CC-Link IE Field and CC-Link IE TSN.

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset		
		23□	17□						
CCI_RUNLEDZ	P00	○	○	O	RUN status output	Low	Hi-Z (High)		
CCI_DLINKLEDZ	P02	○	○		Cyclic communication status output				
CCI_ERRLEDZ	P03	○	○		Field network error status output				
CCI_LERR1LEDZ	P04	○	○		Link error status output 1				
CCI_LERR2LEDZ	P05	○	○		Link error status output 2				
CCI_SDLEDZ	P06	○	×		Transmission status output				
	EXTP12	×	○						
CCI_RDLEDZ	P07	○	×		Port reception status output				
	EXTP13	×	○						
CCI_NMIZ	P52	○	○	I	Output NMI interrupt to MCU	—	—		
CCI_WDTIZ	P12	○	×		Input from external WDT				
	EXTP11	×	○						
CCI_INTZ	P53	○	×	O	Output interrupt to MCU				
	EXTP10	×	○						
CCI_CLK2_097M	—	○	○	I	2.097152 MHz clock (crystal oscillator)			—	—
CLK2MSEL*1	—	○	○		CC-Link IE Field clock selection signal input 0: 2.097152 MHz (CCI_CLK2_097M) 1: 2 MHz (PLL divided clock)				

Note 1. For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

2.11 System Pins

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
XT1	—	○	○	O	Clock input pin	—	—
XT2	—	○	○	I	When using an oscillator (OSCTH = 1): XT1 is connected to GND and XT2 is connected to the oscillator. When using a Resonator (OSCTH = 0): XT1 and XT2 are connected to the resonator.		
RESETZ	—	○	○		Reset input	Low	
PONRZ	—	○	○		Power-on reset input		
HOTRESETZ	—	○	○		Hot reset input		
OSCTH	—	○	○		External clock input mode setting 0: Resonator connection mode 1: External clock input mode	High	
JTAGSEL	—	○	○		JTAG pin operating mode setting 0: Cortex-M4 JTAG mode 1: B-SCAN JTAG mode	—	
RSTOUTZ	—	○	○	O	External reset output	Low	Low
PLL_VDD	—	○	○	—	PLL power supply (1.15 V)	—	—
PLL_GND	—	○	○		PLL GND		
VDD33	—	○	○		I/O power supply (3.3 V)		
VDD11	—	○	○		Internal power supply (1.15 V)		
GND	—	○	○		Power supply ground voltage (GND)		
GND/OPEN	—	○	×		Power supply ground voltage (GND) or open		

2.12 Trace Pins

Function Name	Pin	PKG		I/O	Description	Active	Level during Reset
	Name	23□	17□				
TRACECLK	—	○	○	O	Trace port clock output	—	Clock output
TRACEDATA3*1	—	○	○		Trace port data output		Hi-Z (High)
TRACEDATA2*1	—	○	○				
TRACEDATA1*1	—	○	○				
TRACEDATA0*1	—	○	○				

Note 1. These pins are used as an input port in the initial state. The pins are switched to an output port after the reset state is released (the RSTOUTZ pin is switched from Low to High) and 150 to 170 ns are passed.

2.13 CPU Power Control Pin

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
SLEEPING	P72	○	○	O	CPU core sleep mode output	High	Hi-Z (High)

2.14 Test Pins

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
TMODE0–TMODE2	—	○	○	I	Renesas dedicated test pins	—	—
TEST3		○	×				
TEST4, TEST5		○	○	I/O			
TEST6		○	○	I			
TEST7		○	○				
TMS		○	○	I/O	Mode select signal	Low	
TDI		○	○	I	Serial data input		
TDO		○	○	O	Serial data output		
TRSTZ		○	○	I	Reset signal		
TCK		○	○		Clock signal (JTAG clock)	—	

2.15 Operating Mode Setting Pins

Function Name	Pin Name	PKG		I/O	Description	Active	Level during Reset
		23□	17□				
BOOT1–BOOT0	—	○	○	I	Boot mode selection 00: External memory boot 01: External serial flash ROM boot 10: External MCU boot 11: Instruction RAM boot (only available for debugging)	—	—
MEMIFSEL	—	○	○		External memory interface selection 0: Slave memory interface 1: External MCU interface		
MEMCSEL	—	○	○		Internal memory controller selection 0: Asynchronous SRAM controller 1: Synchronous burst access memory controller		
BUS32EN	—	○	○		External memory interface bus width selection 0: 16-bit bus 1: 32-bit bus		
HIFSYNC	—	○	○		External MCU interface operating mode selection 0: Asynchronous SRAM interface 1: Synchronous SRAM interface		
HWRZSEL	—	○	○		External MCU interface HWRZ/HBENZ selection 0: Used as HBENZ 1: Used as HWRZ		
ADMUXMODE	—	○	○		Multiplexing of address and data lines 0: Separated address and data lines 1: Multiplexed address and data lines		

The following table lists the combinations of available operating mode setting pins for this product.

Boot mode	External memory boot				External MCU boot				External serial flash ROM boot							
External memory interface	Slave memory interface				External MCU interface				Slave memory interface				External MCU interface			
Memory controller type	Asynchronous		Synchronous		Asynchronous		Synchronous		Asynchronous		Synchronous		Asynchronous		Synchronous	
External bus width	16-bit	32-bit	16-bit	32-bit	16-bit	32-bit	16-bit	32-bit	16-bit	32-bit	16-bit	32-bit	16-bit	32-bit	16-bit	32-bit
BOOT1–0	00	00	00	00	10	10	10	10	01	01	01	01	01	01	01	01
MEMIFSEL	0	0	0	0	1	1	1	1	0	0	0	0	1	1	1	1
MEMCSEL	0	0	1	1	0	0	1	1	0	0	1	1	0	0	1	1
BUS32EN	0	1	0	1	0	1	0	1	0	1	0	1	0	1	0	1
HIFSYNC	0	0	0	0	*1	*1	1	1	0	0	0	0	*1	*1	1	1
HWRZSEL	0	0	0	0	*2	*2	0	0	0	0	0	0	*2	*2	0	0
ADMUXMODE	0	0	*3	*3	0	0	*3	*3	0	0	*3	*3	0	0	*3	*3

Note. Any combination of operating mode setting pins other than above is prohibited.

Note 1. The mode of the external MCU interface is selectable by the level on the HIFSYNC pin.

HIFSYNC = 0: Asynchronous SRAM supported MCU connection mode

HIFSYNC = 1: Synchronous SRAM supported MCU connection mode

For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

2. The external MCU interface HWRZ or HBENZ is selectable by the level on the HWRZSEL pin.

For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

3. Multiplexing of address and data lines is selectable by the level on the ADMUXMODE pin.

For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

Remarks 1. The combination of operating mode setting pins used to select booting for instruction RAM (BOOT1–0 = 11) is the same as that for booting from external memory (BOOT1–0 = 00).

2. Asynchronous: Asynchronous SRAM controller (MEMCSEL = 0)

Synchronous: Synchronous burst access memory controller (MEMCSEL = 1)

3. Electrical Characteristics

3.1 Terminology

Table 3.1 Terms Used in Absolute Maximum Ratings

Parameter	Symbol	Meaning
Power supply voltage	V_{DD}	Indicates the voltage range within which damage or reduced reliability will not result when power is applied to a VDD pin.
Input voltage	V_I	Indicates the voltage range within which damage or reduced reliability will not result when power is applied to an input pin.
Output voltage	V_O	Indicates the voltage range within which damage or reduced reliability will not result when power is applied to an output pin.
Output current	I_O	Indicates the absolute tolerance value for DC current to prevent damage or reduced reliability when a current flows out of or into an output pin.
Operating ambient temperature	T_A	Indicates the ambient temperature range for normal logic operations.
Storage temperature	$T_{Sgt.}$	Indicates the element temperature range within which damage or reduced reliability will not result while no voltage or current is being applied to the device.

Table 3.2 Terms Used in Recommended Operating Range

Parameter	Symbol	Meaning
Power supply voltage	V_{DD}	Indicates the voltage range for normal logic operations that occur when $V_{SS} = 0$ V.
High-level input voltage	V_{IH}	A voltage, which is applied to the input pins of the R-IN32M4-CL3, indicating that the high level state for normal operation of the input buffer. – If a voltage that is equal to or greater than the minimum value is applied, the input voltage is guaranteed as a high level voltage.
Low-level input voltage	V_{IL}	A voltage, which is applied to the input pins of the R-IN32M4-CL3, indicating that the low level state for normal operation of the input buffer. – If a voltage that is equal to or less than the maximum value is applied, the input voltage is guaranteed as a low level voltage.
Positive trigger voltage	V_P	Indicates the input level at which the output level is inverted when the input to the R-IN32M4-CL3 is changed from the low-level side to the high-level side.
Negative trigger voltage	V_N	Indicates the input level at which the output level is inverted when the input to the R-IN32M4-CL3 is changed from the high-level side to the low-level side.
Hysteresis voltage	V_H	Indicates the differential between the positive trigger voltage and the negative trigger voltage.
Input rising time	$t_{ried},$ $t_{ric},$ t_{ris}	Indicates the limit value for the time period when an input voltage applied to R-IN32M4-CL3 rises from 10% to 90%. t_{ried} , t_{ric} , and t_{ris} each indicate the input rising time for the data, clock, and Schmitt buffer.
Input falling time	$t_{fid},$ $t_{fic},$ t_{fis}	Indicates the limit value for the time period when an input voltage applied to R-IN32M4-CL3 falls from 90% to 10%. t_{fid} , t_{fic} , and t_{fis} each indicate the input falling time for the data, clock, and Schmitt buffer.

Table 3.3 Terms Used for DC Characteristics

Parameter	Symbol	Meaning
Off-state output current	I_{OZ}	Indicates the current that flows via an output pin when the rated voltage is applied when a tri-state output has high impedance.
Output short circuit current	I_{OS}	Indicates the current that flows when the output pins are shorted to the ground when output is at high level.
Input leakage current	I_{LI}	Indicates the current that flows via an input pin when a voltage is applied to that pin.
Low-level output current	I_{OL}	Indicates the current that flows through the output pin when the rated low-level voltage is outputting.
High-level output current	I_{OH}	Indicates the current that flows from the output pin when the rated high-level voltage is outputting.
Low-level output voltage	V_{OL}	Indicates the output voltage at low level.
High-level output voltage	V_{OH}	Indicates the output voltage at high level.

3.2 Absolute Maximum Ratings

Table 3.4 Absolute Maximum Ratings

Item	Symbol	Conditions	Ratings	Unit
Power supply voltage	V_{DD}	1.15 V power supply	-0.3 to +1.265	V
		2.5 V power supply	-0.3 to +2.75	V
		3.3 V power supply	-0.3 to +4.20	V
I/O voltage	V_I/V_O	3.3 V buffer $V_I/V_O < V_{DD} + 0.3$ V	-0.3 to +4.20	V
		Gigabit Ethernet PHY MDI (Px_DyP/Px_DyN) x = 0, 1, y = 0 to 3	-0.3 to +2.75	V
	V_I	5 V-tolerant buffer	-0.3 to +5.80	V
	V_O		-0.3 to +4.20	V
Output current (3.3 V buffer)	I_O	8mA type	16.0	mA
		10mA type	22.3	mA
		12mA type	27.6	mA
Output current (5 V-tolerant buffer)	I_O	4mA type (5 V-tolerant buffer)	10.2	mA
Operating ambient temperature	T_A	—	-40 to +85	°C
Storage temperature	$T_{Sgt.}$	—	-55 to +125	°C
Junction temperature	T_j	—	-40 to +125	°C

Note. Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

Remark. Be sure to apply voltage to the I/O pins only after the supply voltage has been fixed.

3.3 Recommended Operating Conditions

Table 3.5 Recommended Operating Conditions

Item	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Power supply voltage	V_{DD}	1.15 V power supply	1.09	1.15	1.21	V
		2.5 V power supply	2.375	2.5	2.625	V
		3.3 V power supply	3.135	3.3	3.465	V
Negative trigger voltage	V_N	3.3 V buffer	0.8	—	1.8	V
		5 V-tolerant buffer	0.8	—	1.8	V
Positive trigger voltage	V_P	3.3 V buffer	1.1	—	2.4	V
		5 V-tolerant buffer	1.1	—	2.1	V
Hysteresis voltage	V_H	3.3 V buffer	0.15	—	1.1	V
		5 V-tolerant buffer	0.15	—	1.1	V
Low-level input voltage	V_{IL}	3.3 V buffer	-0.3	—	0.8	V
		3.3 V OSC buffer	-0.3	—	0.8	V
		5 V-tolerant buffer	-0.3	—	0.8	V
High-level input voltage	V_{IH}	3.3 V buffer	2.2	—	$V_{DD} + 0.3$	V
		3.3 V OSC buffer	2.4	—	$V_{DD} + 0.3$	V
		5 V-tolerant buffer	2.2	—	5.8	V
Input rising/falling time	t_{ried}	—	0	—	200	ns
	t_{fid}	—	0	—	200	ns
Input rising/falling time (clock)	t_{ric}	—	0	—	4	ns
	t_{fic}	—	0	—	4	ns
Input rising/falling time (Schmitt input)	t_{ris}	—	0	—	1	ms
	t_{fis}	—	0	—	1	ms
Operating ambient temperature	T_A	—	-40	—	85	°C

3.4 DC Characteristics

Table 3.6 DC Characteristics ($V_{DD} = 3.3 \pm 0.165$ V, $T_A = -40$ to $+85^\circ\text{C}$) (1/2)

Item	Symbol	Conditions			MIN.	TYP.	MAX.	Unit
Operating current consumption	I_{DD}	$V_I = V_{DD}$ or GND	Without 2.5-V built-in Regulator	VDD11, VDD11A	—	325	515	mA
				VDD25A	—	280	320	
				VDD33*2	—	28	—	mA
			With 2.5-V built-in Regulator	VDD11, VDD11A	—	325	515	mA
				VDD25A	—	—	—	
				VDD33*2	—	28	—	mA
				VDDREG_33, AVDDREG_33	—	248	289	mA
Off-state current	I_{OZ}	$V_I = V_{DD}$ or GND	3.3 V output		—	—	± 10	μA
		$V_I = \text{GND}$	5 V-tolerant buffer		—	—	-10	μA
		$V_I \leq 5.8$ V			—	—	+10	μA
Output short circuit current*1	I_{OS}	$V_O = \text{GND}$	—		—	—	-250	mA
Input leakage current (3.3 V buffer)	I_I	$V_I = V_{DD}$ or GND	Normal input		—	—	± 10	μA
		$V_I = \text{GND}$	With pull-up resistor (130 k Ω)		-6.7	—	-195	μA
		$V_I = V_{DD}$	With pull-down resistor (160 k Ω)		6.7	—	195	μA
Input leakage current (5 V-tolerant buffer)	I_I	$V_I = \text{GND}$	With pull-up resistor (130 k Ω)		-6.7	—	-195	μA

Note 1. The output short circuit time is no more than one second and is only for one pin.

2. The operating current of I/O differs depending on the conditions (for example, loads, waveform distortion, and toggle frequency). Measure actual current under the mounting environment.

Remark. The (+) and (-) signs in the table indicate the current direction. Current flowing to the device is indicated by (+) and current flowing out is indicated by (-).

Table 3.7 DC Characteristics ($V_{DD} = 3.3 \pm 0.165$ V, $T_A = -40$ to $+85^\circ\text{C}$) (2/2)

Item	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Low-level output current (3.3 V buffer)	I_{OL}	$V_{OL} = 0.4$ V	8 mA type	8.0	—	mA
			10 mA type	10.0	—	mA
			12 mA type	12.0	—	mA
Low-level output current (5 V-tolerant buffer)	I_{OL}	$V_{OL} = 0.4$ V	4 mA type	4.0	—	mA
High-level output current (3.3 V buffer)	I_{OH}	$V_{OH} = V_{DD} - 0.4$ V	8 mA type	-8.0	—	mA
			10 mA type	-10.0	—	mA
			12 mA type	-12.0	—	mA
High-level output current (5 V-tolerant buffer)	I_{OH}	$V_{OH} = V_{DD} - 0.4$ V	4 mA type	-4.0	—	mA
Low-level output voltage	V_{OL}	$I_{OL} = 0$ mA	3.3 V buffer	—	—	0.1 V
			5 V-tolerant buffer	—	—	0.1 V
High-level output voltage	V_{OH}	$I_{OL} = 0$ mA	3.3 V buffer	$V_{DD} - 0.1$ V	—	— V
			5 V-tolerant buffer	$V_{DD} - 0.1$ V	—	— V

Table 3.8 DC Characteristics (2.5-V built-in Regulator: $V_{DD} = 3.3 \pm 0.165$ V, $T_A = -40$ to $+85^\circ\text{C}$)

Item	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output voltage	V_{DD}	REG_OUT pin*	2.5 - 3%	—	2.5 + 3%	V
Output current	I_o		—	—	400	mA
Conversion efficiency	—	—	—	80	—	%

Note. The power supply of 2.5 V via the REG_OUT pin is dedicated to the VDD25A.

The pin is not available for 2.5 V power supply to other devices.

3.5 Pull-Up/Pull-Down Resistor Values

Table 3.9 Pull-Up/Pull-Down Resistor Values ($V_{DD} = 3.3 \pm 0.165$ V, $T_A = -40$ to $+85^\circ\text{C}$)

Item	Library Specification	MIN.	TYP.	MAX.	Unit
Pull-up resistor (3.3 V buffer)	130 k Ω	18	130	450	k Ω
Pull-down resistor (3.3 V buffer)	160 k Ω	18	160	450	k Ω
Pull-up resistor (5 V-tolerant buffer)	130 k Ω	18	130	450	k Ω

3.6 Pin Capacitance

Table 3.10 Pin Capacitance

Item	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input buffer	C_B	XT2 pin	—	—	7.0	pF
		Other than XT2 pin	—	—	10.0	pF
Output buffer		—	—	—	10.0	pF
I/O buffer		—	—	—	10.0	pF

3.7 Power-On/Off Sequence

Table 3.11 lists external power supplies to R-IN32M4-CL3. Figure 3.1 and Figure 3.3 show the power-on/off sequence. There is no particular rule for the power-on sequence. We recommend supplying external power voltage VDD11 first and then supplying external power voltage VDD33. On the other hand, when turning off the power, disconnect VDD33, then VDD11.

If VDD33 is supplied first, note that the I/O modes of the I/O buffers are not fixed and outputs become undefined over the period between VDD33 and VDD11 rising to their thresholds.

3.3 V must be applied to the input pins only after the power supply voltages have been applied.

Table 3.11 External Power Supplies

External power supply	Voltage [V]	External pin name
VDD33	$3.3 \pm 0.165^*$	VDD33 VDDREG_33 AVDDREG_33
VDD25	$2.5 \pm 0.125^*$	VDD25A
VDD11	$1.15 \pm 0.06^*$	VDD11 VDD11A PLL_VDD

Note. Ripple incorporated value. As a target value, set the DC component to within $\pm 3\%$ and the ripple component to within $\pm 2\%$.

3.7.1 Power-On/Off Sequence without 2.5-V built-in Regulator

(1) Supplying Power Voltages

Supply power voltages so that the following two conditions are both satisfied.

- 1) The period from when VDD33, VDD25, or VDD11 reaches 10% VDD to when all of them reach 90% VDD or higher is within 100 ms.
- 2) The period from when VDD33, VDD25, or VDD11 reaches 95% VDD to when all of them reach 95% VDD or higher is within 50 ms.

(2) Turning Off Power Voltages

Turn off power voltages so that the following two conditions are both satisfied.

- 1) The period from when VDD33, VDD25, or VDD11 reaches 90% VDD to when all of them reach 10% VDD or lower is within 100 ms.
- 2) The period from when VDD33, VDD25, or VDD11 reaches 95% VDD to when all of them reach 95% VDD or lower is within 50 ms.

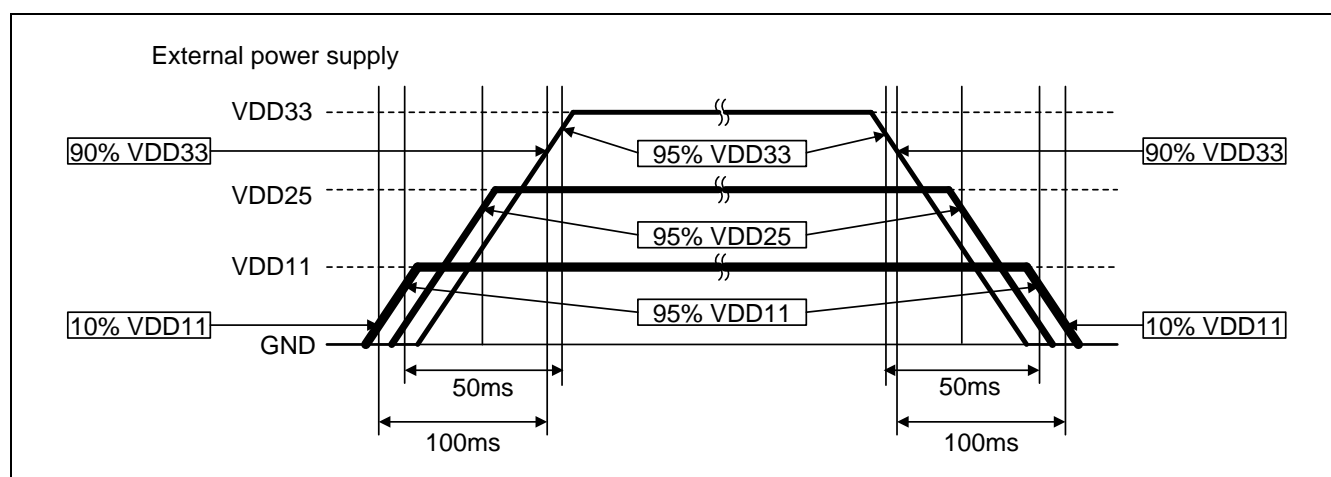


Figure 3.1 Power-On/Off Sequence (without 2.5-V built-in Regulator)

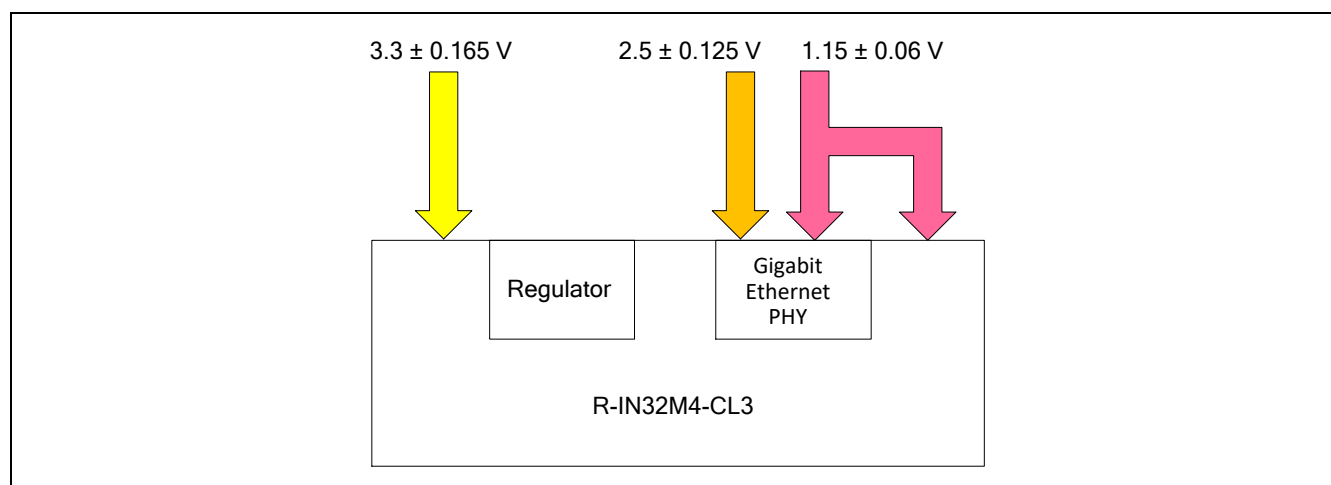


Figure 3.2 Power Supply Path to R-IN32M4-CL3 (without 2.5-V built-in Regulator)

3.7.2 Power-On/Off Sequence with 2.5-V built-in Regulator

(1) Supplying Power Voltages

Supply power voltages so that the following two conditions are both satisfied.

- 1) The period from when VDD33 or VDD11 reaches 10% VDD to when both of them reach 90% VDD or higher is within 100 ms.
- 2) The period from when VDD33 or VDD11 reaches 95% VDD to when both of them reach 95% VDD or higher is within 49 ms.

(2) Turning Off Power Voltages

Turn off power voltages so that the following two conditions are both satisfied.

- 1) The period from when VDD33 or VDD11 reaches 90% VDD to when both of them reach 10% VDD or lower is within 100 ms.
- 2) The period from when VDD33 or VDD11 reaches 95% VDD to when both of them reach 95% VDD or lower is within 49 ms.

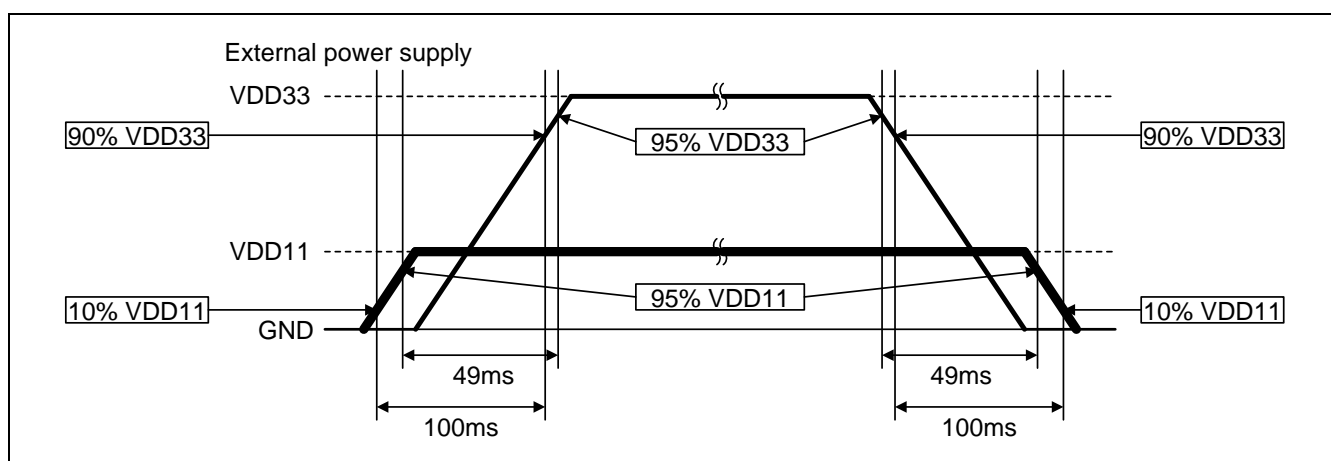


Figure 3.3 Power-On/Off Sequence (with 2.5-V built-in Regulator)

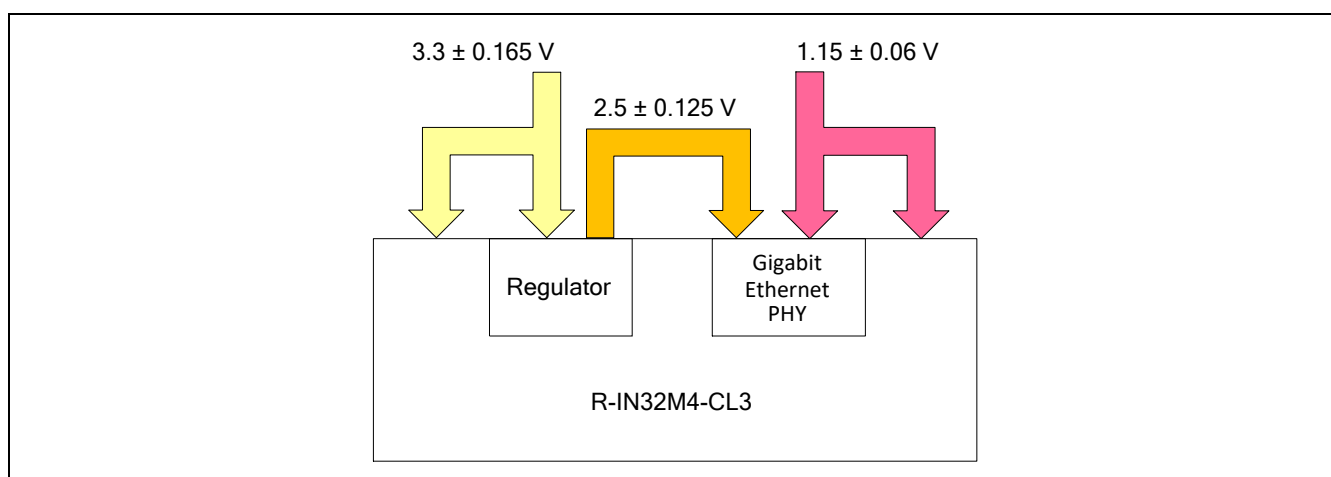


Figure 3.4 Power Supply Path to R-IN32M4-CL3 (with 2.5-V built-in Regulator)

3.8 AC Characteristics

3.8.1 Clock Pins

(1) Input Clocks

Item	Symbol	Conditions	MIN	MAX	Unit
XT1 and XT2 clock frequency	t_{SYSCLK}	When the resonator is used (OSCTH pin = 0)	25 ± 50 ppm, 5 ps-rms		MHz
XT2 clock frequency		When the oscillator is used	25 ± 50 ppm, 5 ps-rms		MHz
XT2 clock duty		(OSCTH pin = 1)	45	55	%
CCI_CLK2_097M	t_{CCIECLK}	—	2.097152 ± 100 ppm		MHz
HBUSCLK	t_{HBUSCLK}	—	—	50	MHz
CSISCK0, CSISCK1	t_{CSISSCK}	Slave mode	—	16.6	MHz
TCK	t_{TCK}	—	—	50	MHz

(2) Output Clocks

Item	Symbol	Conditions	MIN	MAX	Unit
BUSCLK output cycle	t_{BUSCLK}	$C_L = 15$ pF	10	—	ns
BUSCLK High-level width	t_{BCKH}		$0.5 \times t_{\text{BUSCLK}} - 2.0$	$0.5 \times t_{\text{BUSCLK}} + 2.0$	ns
BUSCLK Low-level width	t_{BCKL}		$0.5 \times t_{\text{BUSCLK}} - 2.0$	$0.5 \times t_{\text{BUSCLK}} + 2.0$	ns
BUSCLK rising time	t_{BCKR}		—	1.2	ns
BUSCLK falling time	t_{BCKF}		—	1.2	ns
CSISCK0 and CSISCK1 output frequency	t_{CSIMSCK}	Master mode $C_L = 15$ pF	—	25	MHz
SCL0 and SCL1 output frequency	t_{SCL}	High-speed mode $C_L = 30$ pF	—	400	kHz
SMSCK output frequency	t_{SMSCK}	$C_L = 15$ pF	—	50	MHz
TRACECLK output frequency	t_{TRACECLK}	$C_L = 15$ pF	—	50	MHz

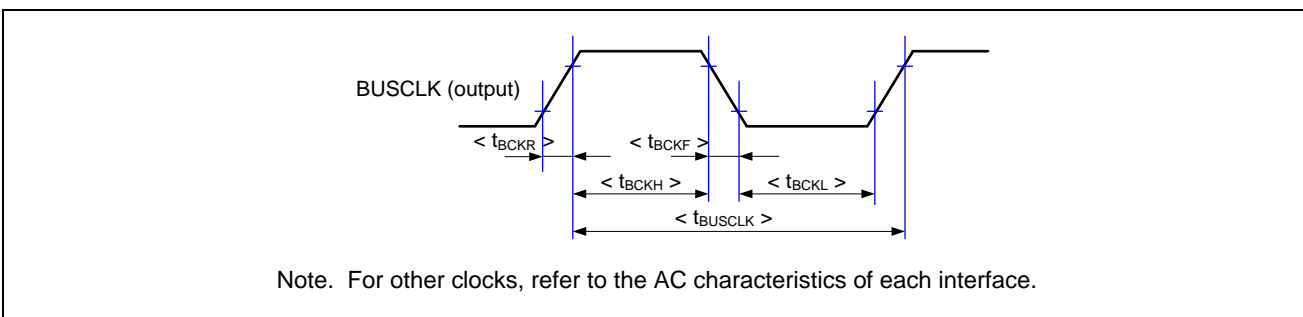


Figure 3.5 Output Clock Timing

3.8.2 Reset Pins

Item	Symbol	Conditions	MIN	MAX	Unit
RESETZ input Low-level width	t_{WRSL}	—	Secure the time (oscillation stabilization time of the external oscillator circuit + 1 μ sec).	—	ns
HOTRESETZ input Low-level width	t_{WHRSL}	—		—	ns
PONRZ input Low-level width	t_{WPRSL}	—		—	ns
PONRZ input timing (for RESETZ \uparrow)	t_{SKPR}	—	0	—	ns

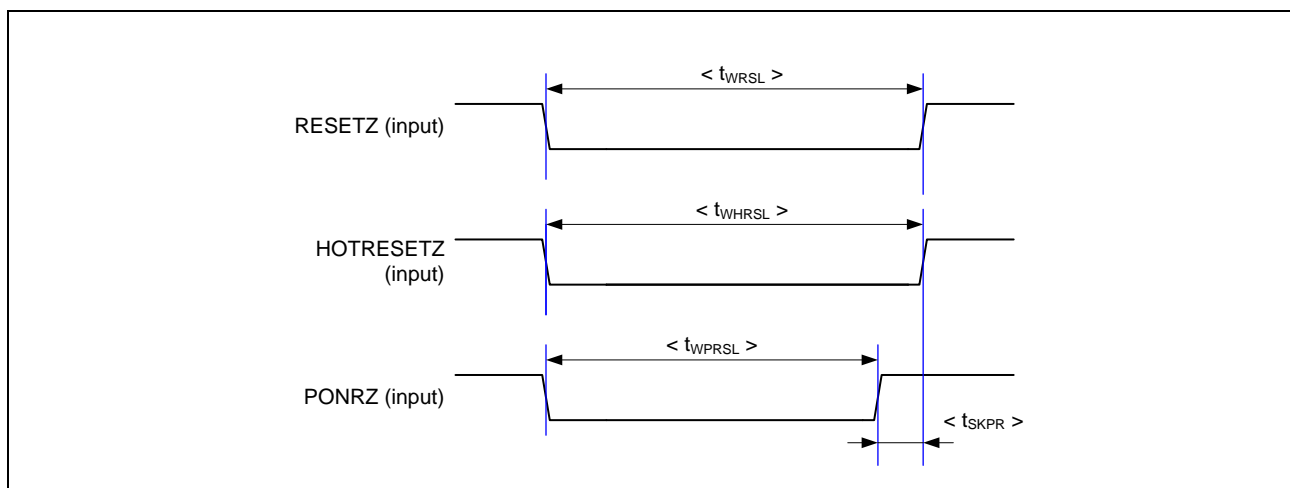


Figure 3.6 Reset Timing

3.8.3 External Memory Interface Pins

(1) How to calculate a delay value due to the external load

For the external memory interface pins of R-IN32M4-CL3, the listed values are for a load of 0 pF, but the actual loads will differ with users. Calculate the timing in accordance with the load conditions of the user. The user must also consider the wiring delay on the board.

Driving Ability	Delay Value per pF (ns)	
	MIN.	MAX.
8 mA	0.024	0.064
12 mA	0.013	0.039

Calculation Example:

When an address pin (8 mA output buffer) has a 30 pF load, the actual delay is as follows.

MIN. 1.0 ns (Minimum delay value for the load of 0 pF) + (0.024 × 30) ns = 1.72 ns

MAX. 7.0 ns (Maximum delay value for the load of 0 pF) + (0.064 × 30) ns = 8.92 ns

(2) Asynchronous SRAM controller access timing

Item	Symbol	MIN	MAX	Unit
Address and CSZ0–CSZ3 output delay time (for BUSCLK ↑)	t _{DKA}	1.0 (1.72)*	7.0 (8.92)*	ns
RDZ output delay time (for BUSCLK ↑)	t _{DKRD}	1.0 (1.72)*	7.0 (8.92)*	ns
WRZ0–WRZ3 (BENZ0–BENZ3) and WRSTBZ output delay time (for BUSCLK ↑)	t _{DKWR}	1.0 (1.72)*	7.0 (8.92)*	ns
BCYSTZ output delay time (for BUSCLK↑)	t _{DKBSL}	1.0 (1.72)*	7.0 (8.92)*	ns
WAITZ input setup time (for BUSCLK↓)	t _{SKW}	4.0	—	ns
WAITZ input hold time (for BUSCLK↓)	t _{HKW}	0	—	ns
Data input setup time (for BUSCLK↑)	t _{SKID}	4.0	—	ns
Data input hold time (for BUSCLK↑)	t _{HKID}	0	—	ns
Data output delay time (for BUSCLK↑)	t _{DKOD}	1.0 (1.72)*	7.0 (8.92)*	ns
Data float delay time (for BUSCLK↑)	t _{HKOD}	1.0 (1.72)*	7.0 (8.92)*	ns

Note. Values in parenthesis are the calculation results for the driving ability of 8 mA and the external load of 30 pF.

(a) Read timing

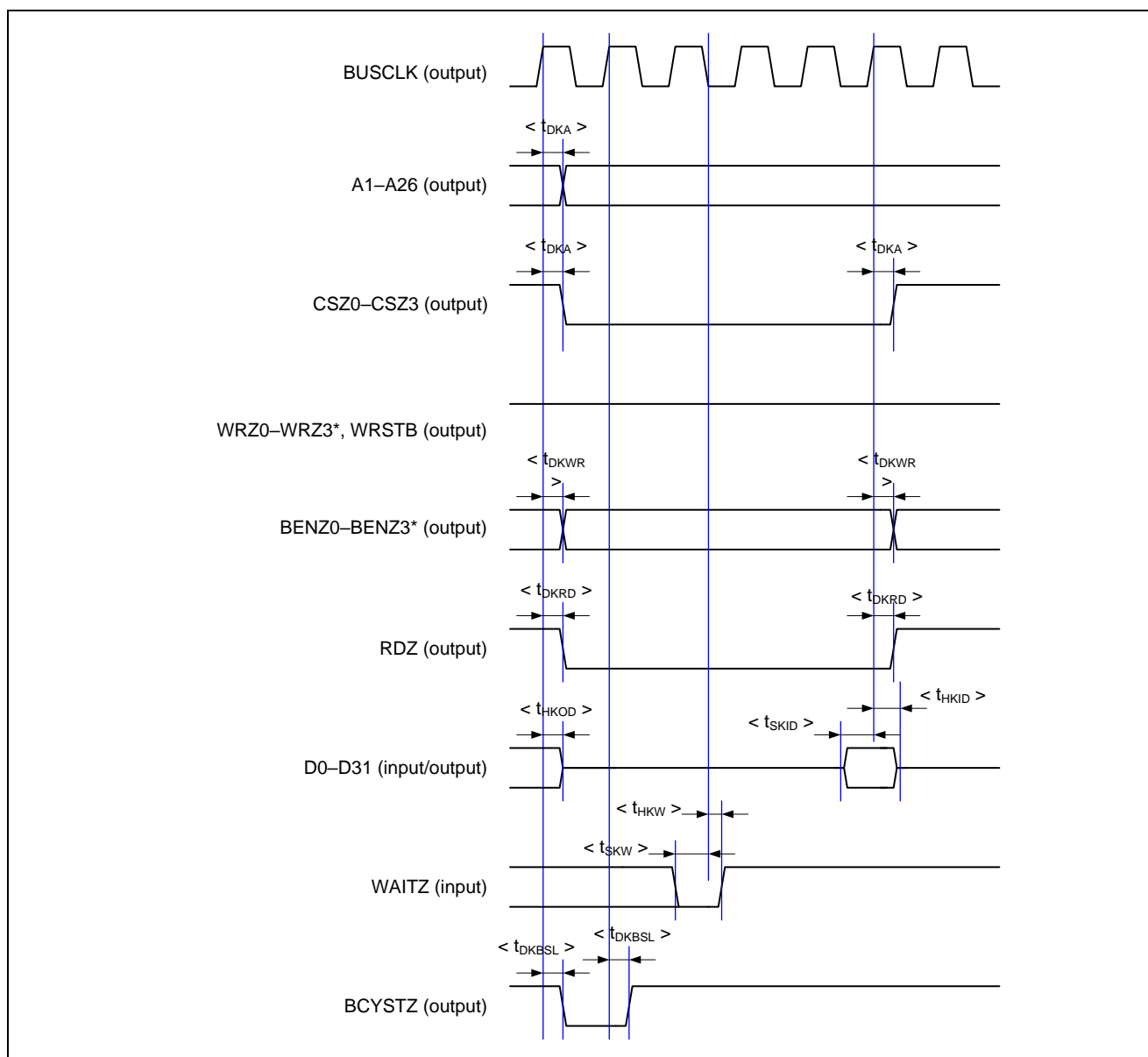


Figure 3.7 Memory Controller Read Timing (Asynchronous Memory)

Note. The WRZ0–WRZ3 pins are multiplexed with the BENZ0–BENZ3 pin functions. The pin names are WRZ0–WRZ3.

The WRZ0–WRZ3 pins are selected by default during a reset. Use the write enable switching register (WREN) to switch the pin functions of these pins.

For register details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

Remark. The above timing is for the case where the settings in the SMCn register for numbers of idle wait cycles, write recovery wait cycles, and address setting wait cycles are 0, and that for data wait cycles is 3.

(b) Write timing

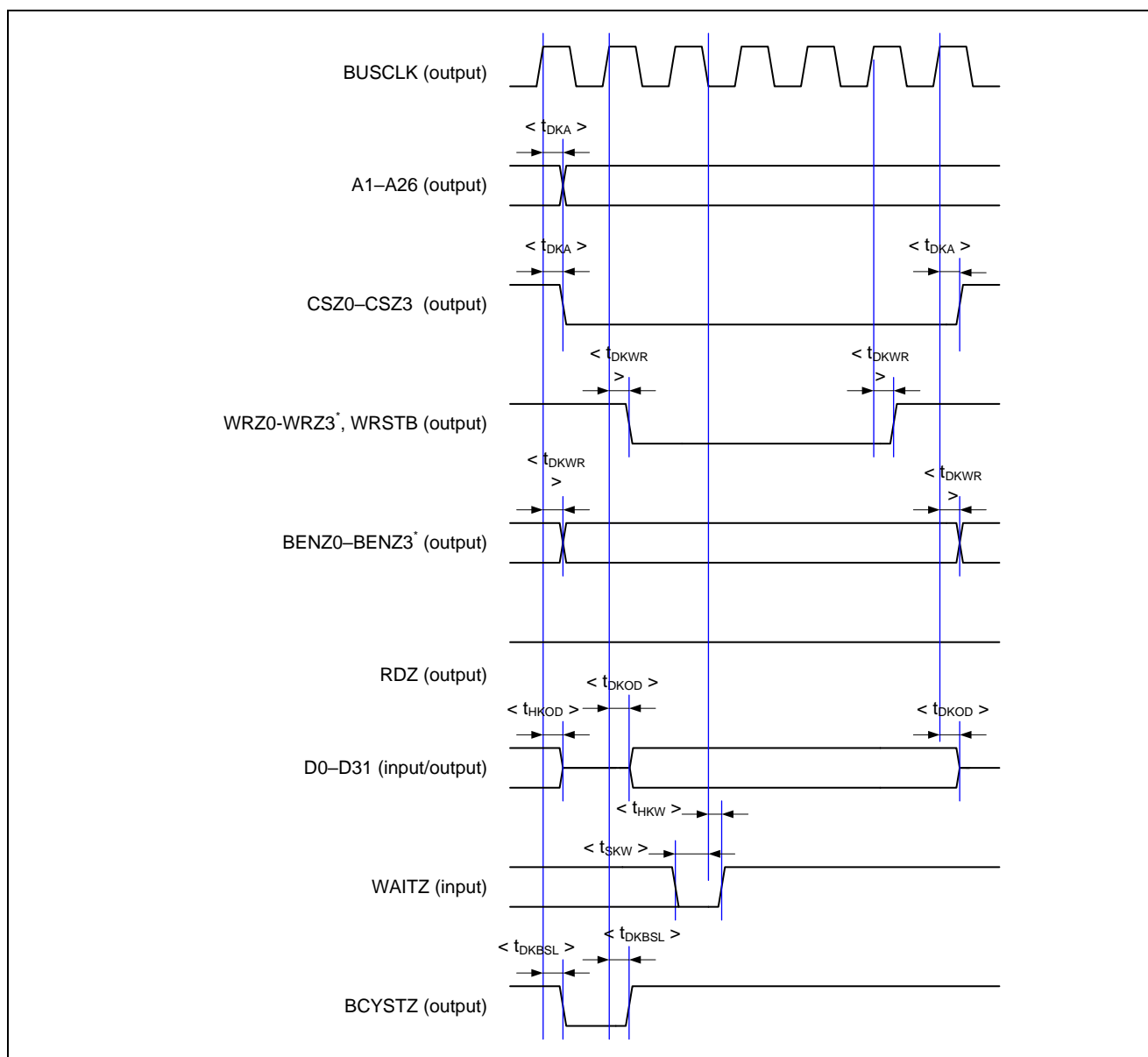


Figure 3.8 Memory Controller Write Timing (Asynchronous Memory)

Note. The WRZ0–WRZ3 pins are multiplexed with the BENZ0–BENZ3 pin functions. The pin names are WRZ0–WRZ3.

The WRZ0–WRZ3 pins are selected by default during a reset. Use the write enable switching register (WREN) to switch the pin functions of these pins.

For register details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

Remark. The above timing is for the case where the settings in the SMCn register for numbers of idle wait cycles, write recovery wait cycles, and address setting wait cycles are 0, and that for data wait cycles is 3.

(3) Synchronous burst access memory controller access timing

Item	Symbol	MIN	MAX	Unit
BUSCLK output frequency	t _{BUSCLK}	—	50	MHz
Address and CSZ0–CSZ3 output delay time	t _{DKA}	1.0 (1.72)*	7.8 (9.72)*	ns
RDZ output delay time	t _{DKRD}	1.0 (1.72)*	7.8 (9.72)*	ns
WRZ0–WRZ3 (BENZ0–BENZ3) and WRSTBZ output delay time	t _{DKWR}	1.0 (1.72)*	7.8 (9.72)*	ns
ADVZ output delay time	t _{DKBSL}	1.0 (1.72)*	7.8 (9.72)*	ns
WAITZ and WAITZ1–WAITZ3 input setup time	t _{SKW}	5.3	—	ns
WAITZ and WAITZ1–WAITZ3 input hold time	t _{HKW}	0	—	ns
Data input setup time	t _{SKID}	5.3	—	ns
Data input hold time	t _{HKID}	0	—	ns
Data output delay time	t _{DKOD}	1.0 (1.72)*	7.8 (9.72)*	ns
Data float delay time	t _{HKOD}	1.0 (1.72)*	7.8 (9.72)*	ns

Note. Values in parenthesis are the calculation results for the driving ability of 8 mA and the external load of 30 pF.

(a) Read timing

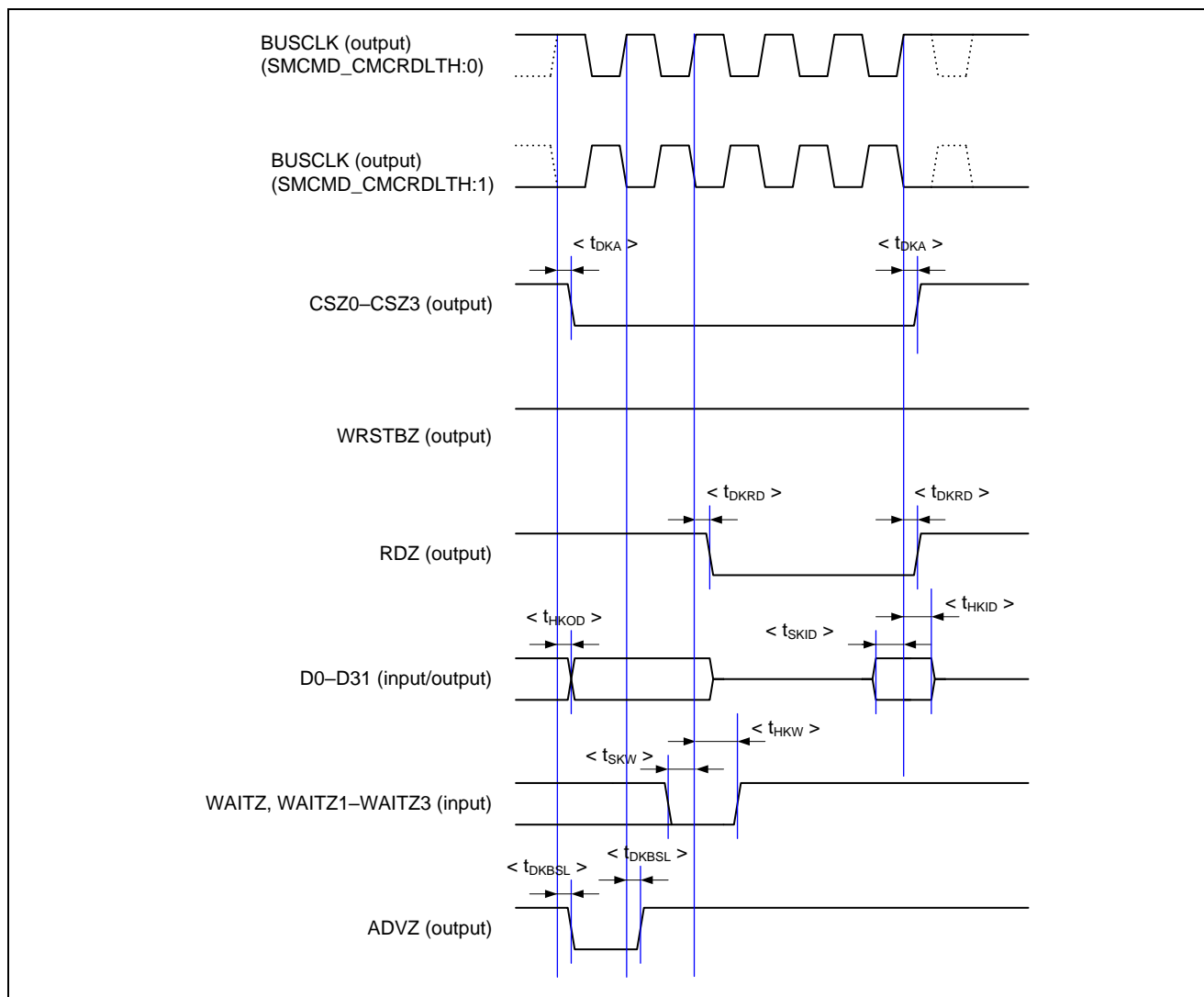


Figure 3.9 Memory Controller Read Timing (Clock Synchronous Memory)

Remark. The above timing is for the case where t_{ceoe} is 2 and t_{rc} is 4.

(b) Write timing

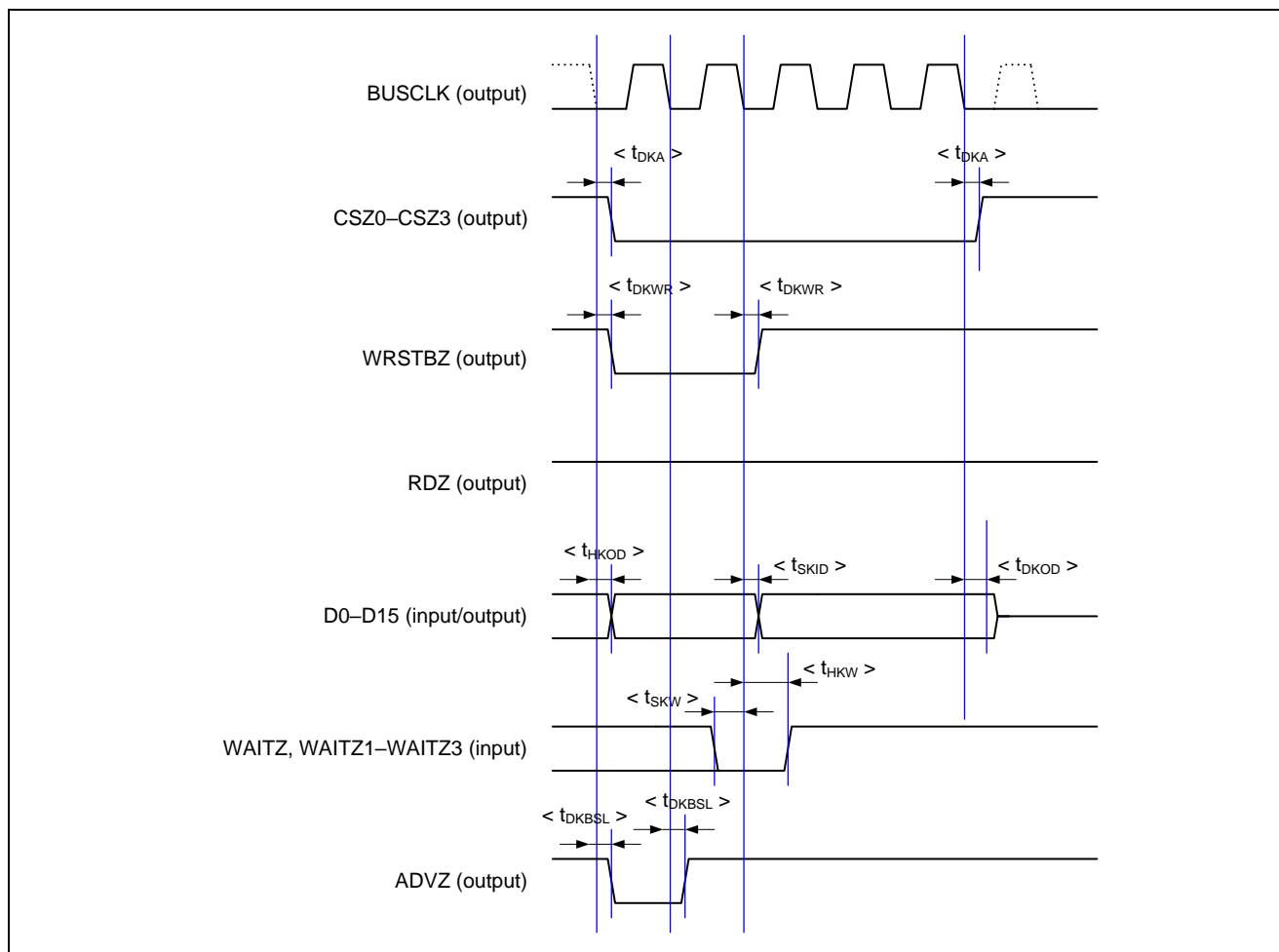


Figure 3.10 Memory Controller Write Timing (Clock Synchronous Memory)

Remark. The above timing is for the case where t_{wp} is 2 and t_{wc} is 5.

3.8.4 External MCU Interface Pins

The load condition for the external MCU interface pins: 65 pF (HD pin) and 35 pF (HWAITZ pin).

(1) Synchronous mode

No.	Item	Symbol	MIN	MAX	Unit
1	HBUSCLK High-level width	t_{HBHIGH}	$0.5 \times t_{HBUSCLK} - 2.1$	$0.5 \times t_{HBUSCLK} + 2.1$	ns
2	HBUSCLK Low-level width	t_{HBLow}	$0.5 \times t_{HBUSCLK} - 2.1$	$0.5 \times t_{HBUSCLK} + 2.1$	ns
3	HBUSCLK input cycle	$t_{HBUSCLK}$	20.0	—	ns
4	Address, HCSZ, HPGCSZ, and HRDZ input setup time (for HBUSCLK \uparrow)	t_{SKHA}	4.0	—	ns
5	HBENZ0–HBENZ3 (HWRZ0–HWRZ3) and HWRSTBZ input setup time (for HBUSCLK \uparrow)	t_{SKHWR}	4.0	—	ns
6	Address, HCSZ, HPGCSZ, and HRDZ input hold time (for HBUSCLK \uparrow)	t_{HKHA}	1.0	—	ns
7	HBENZ0–HBENZ3 (HWRZ0–HWRZ3) and HWRSTBZ input hold time (for HBUSCLK \uparrow)	t_{HKHWR}	1.0	—	ns
8	HWRZ0–HWRZ3, HWRSTBZ recovery time (High-level width)	t_{WHWR}	35.0	—	ns
9	Data input setup time (for HBUSCLK \uparrow)	t_{SKIHD}	4.0	—	ns
10	Data input hold time (for HBUSCLK \uparrow)	t_{HKIHD}	1.0	—	ns
11	HWAITZ output delay time (for HCSZ, HPGCSZ \downarrow)	t_{DKHD}	2.2	—	ns
12	HWAITZ output delay time (for HWRSTBZ, HWRZ0 to HWRZ3 \downarrow)	t_{DKHWT}	2.2	—	ns
13	HWAITZ valid data output delay time (for HBUSCLK \uparrow)	t_{DKHWTV}	2.0	11.0	ns
14	HWAITZ valid data hold time (for HWRSTBZ, HWRZ0–HWRZ3 \uparrow)	t_{HKHWTV}	4.2	—	ns
15	HWAITZ output hold time (for HWRSTBZ, HWRZ0–HWRZ3 \uparrow)	t_{HKWTVR}	—	16.8	ns
16	Data and HWAITZ output hold time (for HCSZ, HPGCSZ \uparrow)	$t_{HKWTVCS}$	—	16.8	ns
17	HRDZ recovery time (High-level width)	t_{WHRD}	35.0	—	ns
18	Data and HWAITZ output delay time (for HRDZ \downarrow)	t_{DKHDHR}	2.2	—	ns
19	Data fixing time (for HWAITZ \uparrow)	$t_{SKHDHWT}$	$t_{HBUSCLK} - 10.0$	—	ns
20	Data and HWAITZ valid data output hold time (for HRDZ \uparrow)	$t_{HKHWTVR}$	2.2	—	ns
21	Data and HWAITZ output hold time (for HRDZ \uparrow)	t_{HKOHDR}	—	16.8	ns
22	Data and HWAITZ output delay time in on-page access (for addresses)	t_{DKPON}	4.2	15.4	ns
23	Data and HWAITZ output delay time in off-page access (for addresses) (when not crossing a 16-byte boundary)	t_{DKPOFF}	4.2	15.4	ns
	Data and HWAITZ output delay time in off-page access (for addresses) (when crossing a 16-byte boundary)	t_{DKPOFF}	4.2	49.5	ns
24	HWAITZ valid data output delay time (for HCSZ, HPGCSZ \downarrow)	$t_{DKWTVCS}$	—	15.4	ns

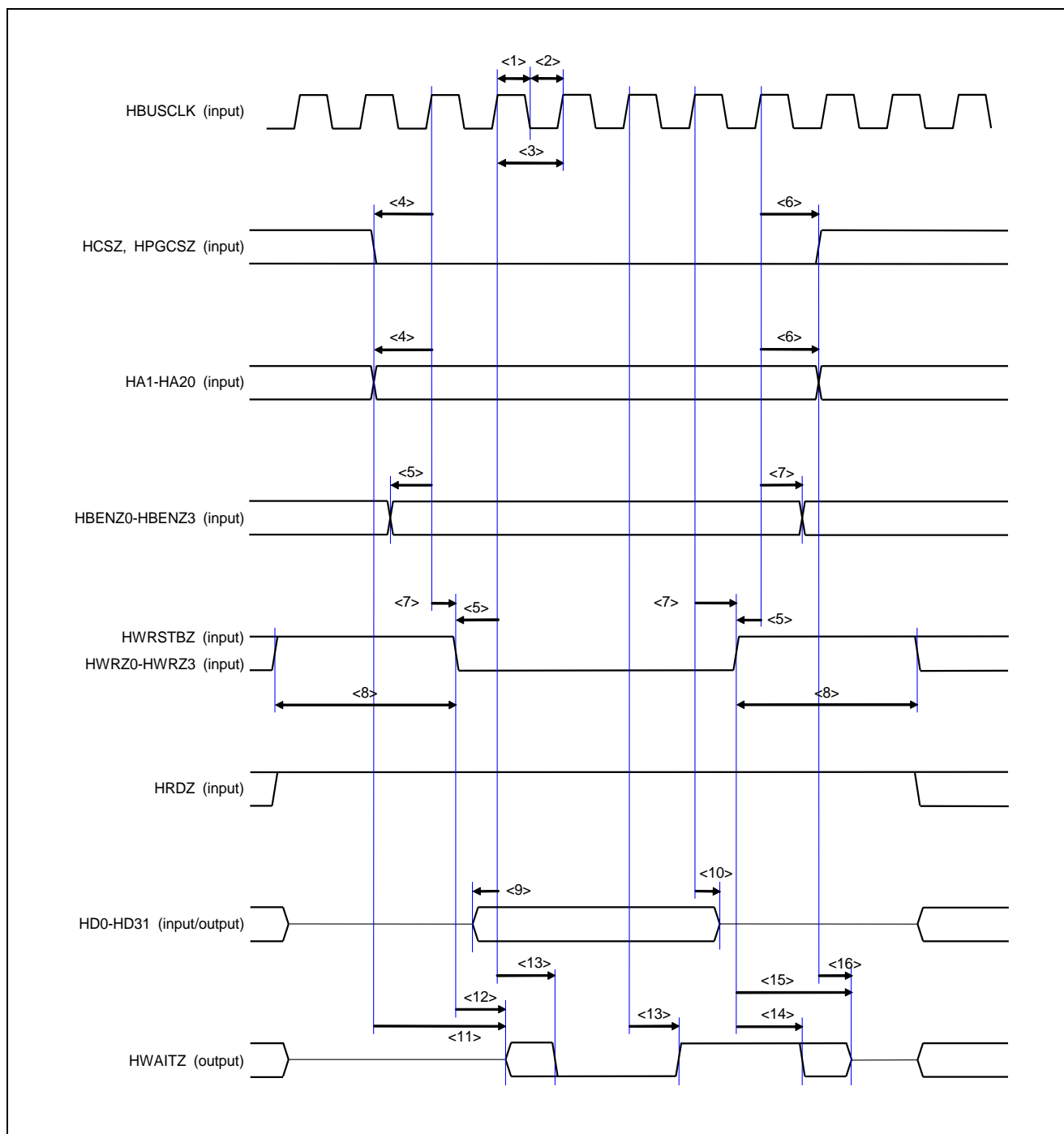


Figure 3.11 External MCU Interface Write Timing (MEMCSEL=L, HIFSYNC=H)

Note. Supply a stable signal to the address, data, and control lines during access.

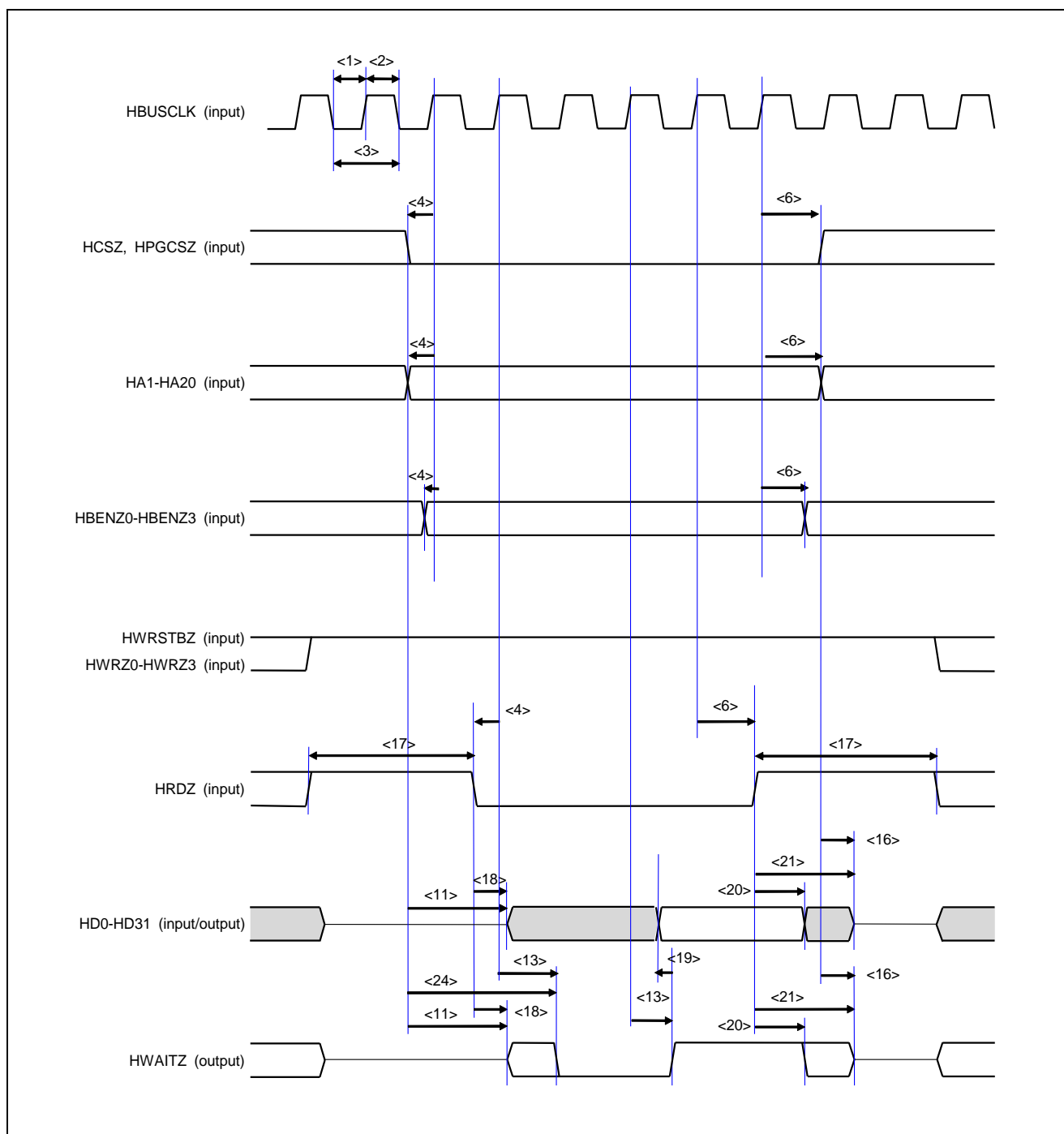


Figure 3.12 External MCU Interface Read Timing (MEMCSEL=L, HIFSINC=H)

Note. Supply a stable signal to the address, data, and control lines during access.

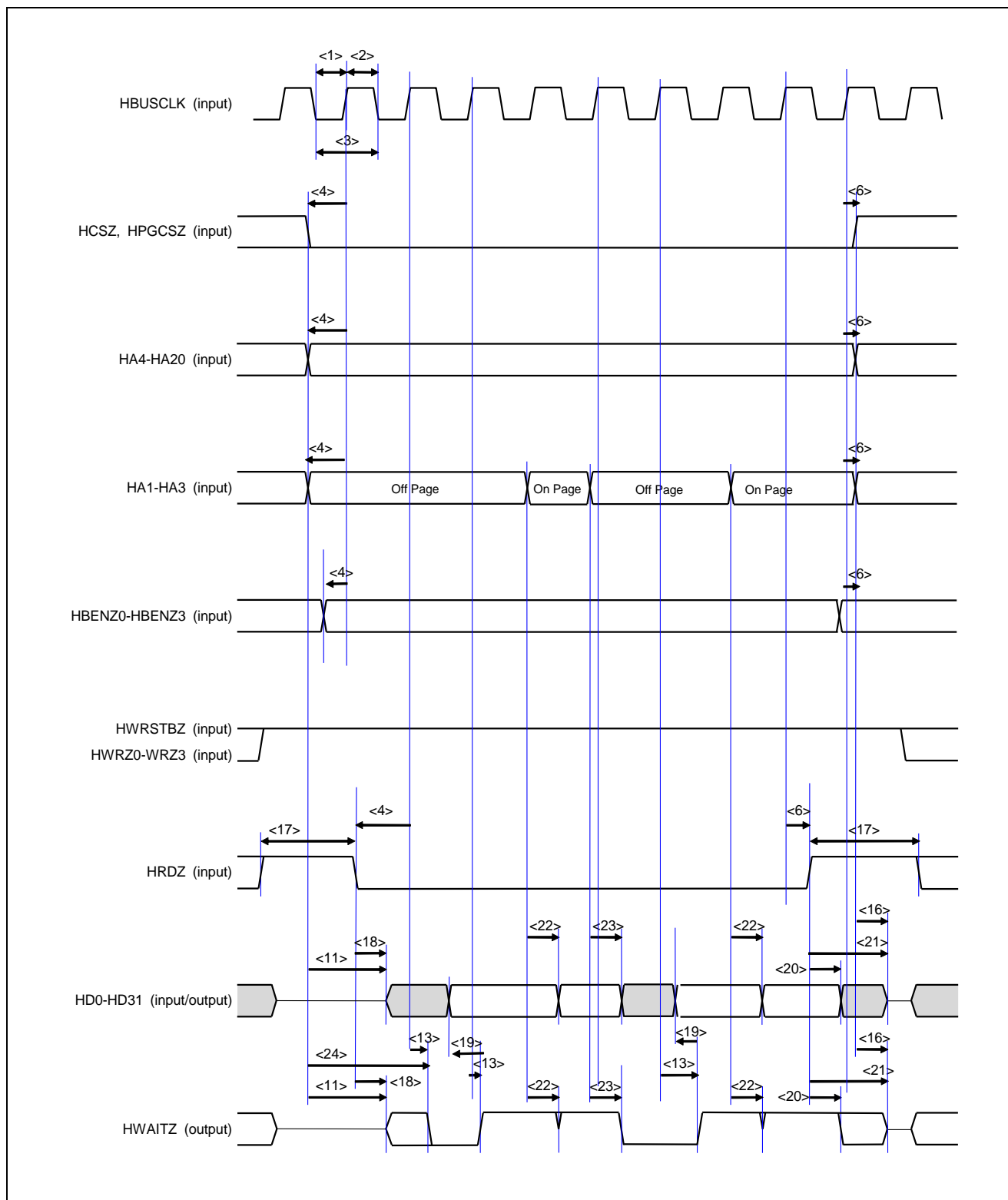


Figure 3.13 External MCU Interface Page Read Timing (MEMCSEL=L, HIFSYNC=H)

Note. Supply a stable signal to the address, data, and control lines during access.

(2) Asynchronous mode

No.	Item	Symbol	MIN	MAX	Unit
1	Address, HCSZ/HPGCSZ, and HBENZ0–HBENZ3 input setup time (for HWRSTBZ, HWRZ0–HWRZ3↓)	t_{ADDWRS}	$7.0^{*1} - 10 \times n$	—	ns
2	HWRZ0–HWRZ3, HWRSTBZ recovery time (High-level width)	t_{WRW}	35.0	—	ns
3	Data input setup time (for HWRSTBZ, HWRZ0–HWRZ3↓)	t_{WRS}	$7.0^{*1} - 10 \times n$	—	ns
4	Data input hold time (for HWRSTBZ, HWRZ0–HWRZ3↑)	t_{WRH}	7.0	—	ns
5	HWAITZ output delay time (for HCSZ or HPGCSZ↓)	t_{CLZ}	2.2	—	ns
6	HWAITZ output delay time (for HWRSTBZ, HWRZ0–HWRZ3↓)	t_{WAITD}	2.2	—	ns
7	HWAITZ valid data output delay time (for HWRSTBZ, HWRZ0–HWRZ3↓)	$t_{WRWAITF}$	—	15.4	ns
8	HWAITZ valid data output hold time (for HWRSTBZ, HWRZ0–HWRZ3↑)	t_{WAITVH}	4.2	—	ns
9	HWAITZ output hold time (for HWRZ0–3, HWRSTBZ↑)	t_{WAITH}	—	16.8	ns
10	Address and HWAITZ output hold time (for HCSZ, HPGCSZ↑)	t_{CHZ}	—	16.8	ns
11	Address, HCSZ, and HPGCSZ input setup time (for HRDZ↓)	t_{ADDRDS}	$6.2^{*2} - 10 \times n$	—	ns
12	Address input hold time in page access (for HRDZ↑)	t_{ADDRDH}	7.0	—	ns
13	HRDZ recovery time (High-level width)	t_{RDW}	35.0	—	ns
14	Data and HWAITZ output delay time (for HRDZ↓)	t_{RDLZ}	2.2	—	ns
15	HWAITZ valid data output delay time (for HRDZ↓)	$t_{RDWAITF}$	—	15.4	ns
16	Data fixing time (for HWAITZ↑)	t_{WAITR}	—	$-6.2^{*3} + 10 \times n$	ns
17	Data and HWAITZ valid data output hold time (for HRDZ↑)	t_{DATAOH}	2.2	—	ns
18	Data and HWAITZ output hold time (for HRDZ↑)	t_{RDHZ}	—	16.8	ns
19	Data and HWAITZ output delay time in on-page access (for addresses)	$t_{PAGEOND}$	4.2	15.4	ns
20	Data and HWAITZ output delay time in off-page access (for addresses) (when not crossing a 16-byte boundary)	$t_{PAGEOFD}$	4.2	15.4	ns
	Data and HWAITZ output delay time in off-page access (for addresses) (when crossing a 16-byte boundary)	$t_{PAGEOFD}$	4.2	49.5	ns
21	HWAITZ valid data output delay time (for HCSZ, HPGCSZ↓)	t_{WAITVD}	—	15.4	ns

Note 1. When the value of WRSTD2–WRSTD0 in the HIFBTC register is 000B.

n: Setting of WRSTD2–WRSTD0

2. When the value of RDSTD1–RDSTD0 in the HIFBTC register is 00B.

n: Setting of RDSTD1–RDSTD0

3. When the value of RDDTS1–RDDTS0 in the HIFBTC register is 00B.

n: Setting of RDDTS1–RDDTS0

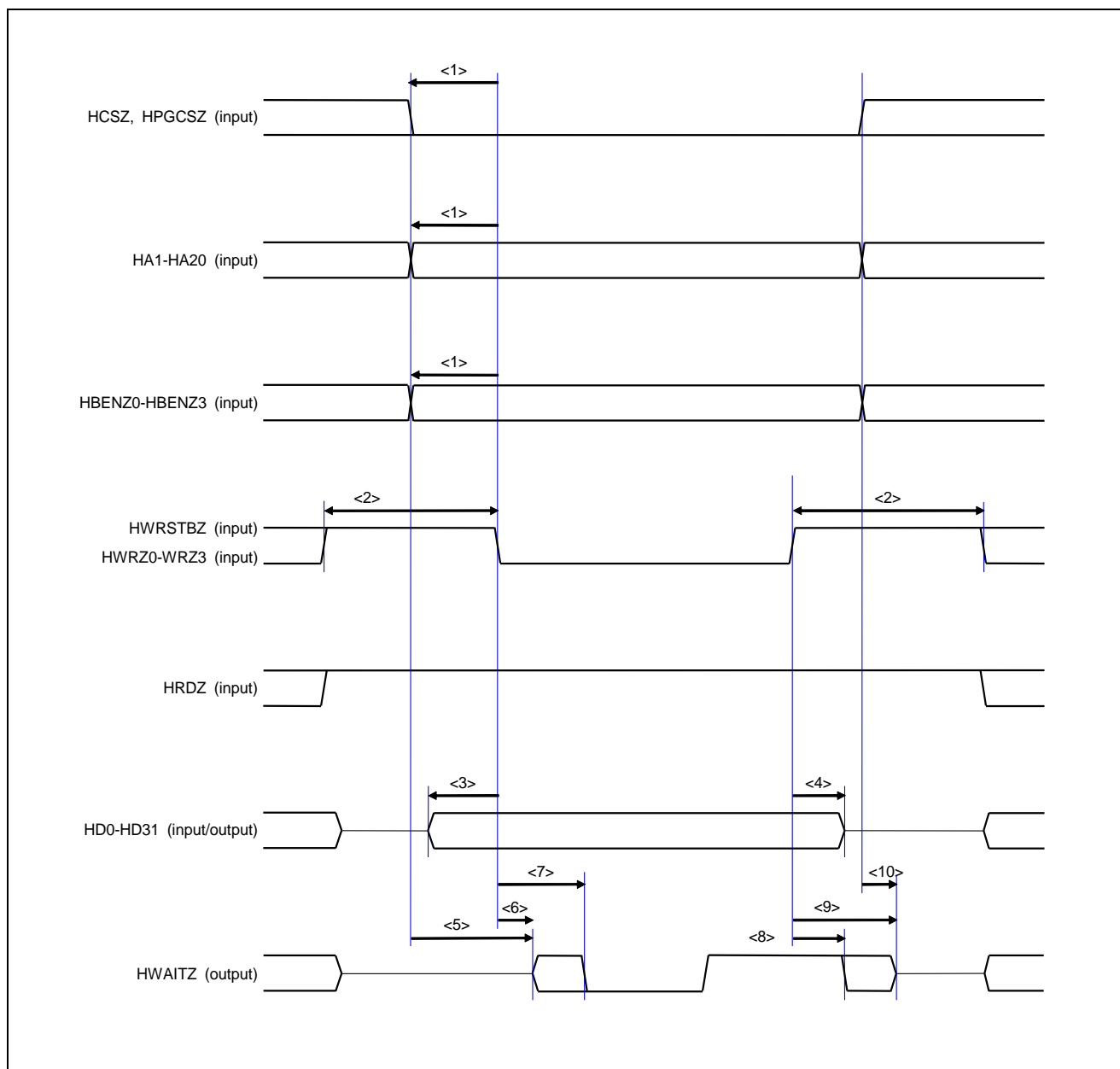


Figure 3.14 External MCU Interface Write Timing (MEMCSEL=L, HIFSYNC=L)

Note. Supply a stable signal to the address, data, and control lines during access.

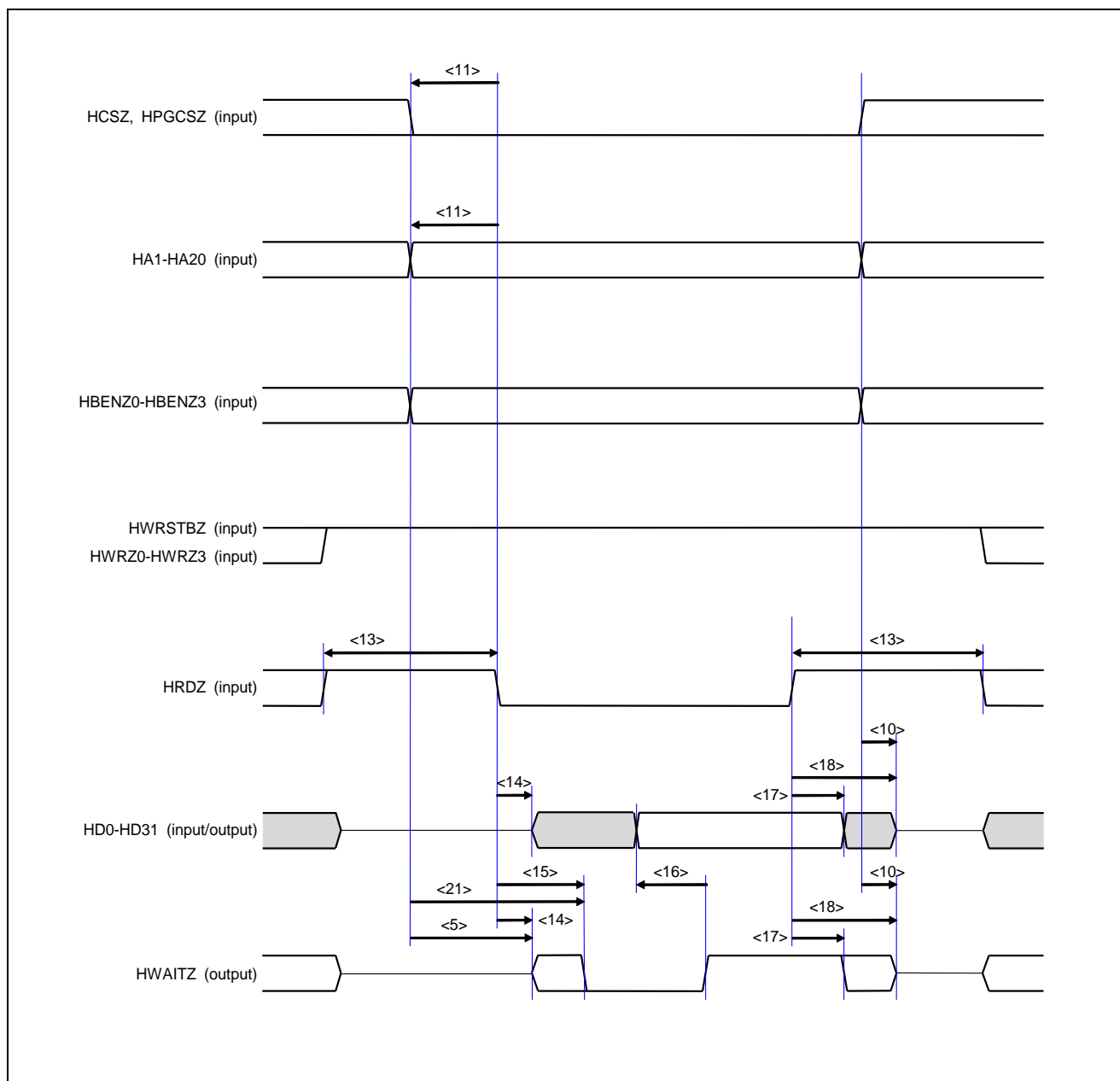


Figure 3.15 External MCU Interface Read Timing (MEMCSEL=L, HIFSUNC=L)

Note. Supply a stable signal to the address, data, and control lines during access.

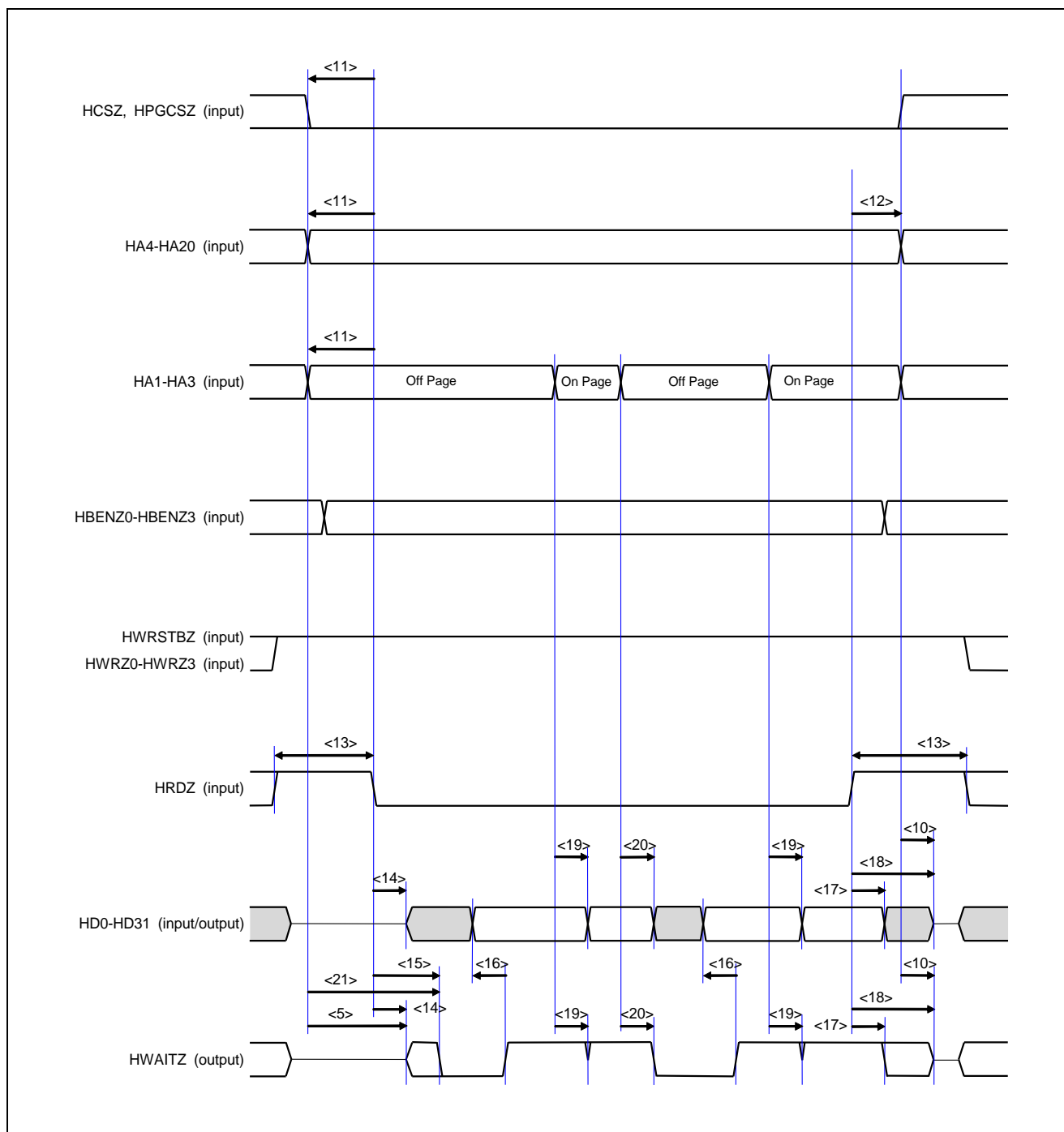


Figure 3.16 External MCU Interface Page Read Timing (MEMCSEL=L, HIFSYNC=L)

Note. Supply a stable signal to the address, data, and control lines during access.

(3) Synchronous SRAM type transfer mode

No.	Item	Symbol	MIN	MAX	Unit
1	HBUSCLK High-level width	t_{HBHIGH}	$0.5 \times t_{HBUSCLK} - 2.1$	$0.5 \times t_{HBUSCLK} + 2.1$	ns
2	HBUSCLK Low-level width	t_{HBLow}	$0.5 \times t_{HBUSCLK} - 2.1$	$0.5 \times t_{HBUSCLK} + 2.1$	ns
3	HBUSCLK input cycle	$t_{HBUSCLK}$	20	—	ns
4	Address and HCSZ/HPGCSZ input setup time (for HBUSCLK ↑)	t_{SKPHA}	4.0	—	ns
5	Address and HCSZ/HPGCSZ input hold time (for HBUSCLK ↑)	t_{HKPCS}	1.0	—	ns
6	Address and HCSZ/HPGCSZ input setup time (for HBUSCLK ↓)	t_{SKNHA}	4.0	—	ns
7	Address, HCSZ, and HPGCSZ input hold time (for HBUSCLK ↓)	t_{HKNHA}	1.0	—	ns
8	HWRZ0–HWRZ3 input setup time (for HBUSCLK ↑)	t_{SKPHWR}	4.0	—	ns
9	HWRZ0–HWRZ3 input hold time (for HBUSCLK ↑)	t_{HKPHWR}	1.0	—	ns
10	HWRZ0–HWRZ3 input setup time (for HBUSCLK ↓)	t_{SKNHWR}	4.0	—	ns
11	HWRZ0–HWRZ3 input hold time (for HBUSCLK ↓)	t_{HKNHWR}	1.0	—	ns
12	HBCYSTZ, HWRSTBZ input setup time (for HBUSCLK ↑)	$t_{SKPHBCY}$	4.0	—	ns
13	HBCYSTZ, HWRSTBZ input hold time (for HBUSCLK ↑)	$t_{HKPHBCY}$	1.0	—	ns
14	HBCYSTZ, HWRSTBZ input setup time (for HBUSCLK ↓)	$t_{SKNHBCY}$	4.0	—	ns
15	HBCYSTZ, HWRSTBZ input hold time (for HBUSCLK ↓)	$t_{HKNHBCY}$	1.0	—	ns
16	HRDZ input setup time (for HBUSCLK ↑)	t_{SKPHRD}	4.0	—	ns
17	HRDZ input hold time (for HBUSCLK ↑)	t_{HKPHRD}	1.0	—	ns
18	HRDZ input setup time (for HBUSCLK ↓)	t_{SKNHRD}	4.0	—	ns
19	HRDZ input hold time (for HBUSCLK ↓)	t_{HKNHRD}	1.0	—	ns
20	Data input setup time (for HBUSCLK ↑)	t_{SKPHD}	4.0	—	ns
21	Data input hold time (for HBUSCLK ↑)	t_{HKPHD}	1.0	—	ns
22	Data input setup time (for HBUSCLK ↓)	t_{SKNHD}	4.0	—	ns
23	Data input hold time (for HBUSCLK ↓)	t_{HKNHD}	1.0	—	ns
24	Data output delay time (for HRDZ ↓)	t_{DKNHRD}	2.2	—	ns
25	Data output hold time (for HRDZ ↑)	t_{HKPHRD}	—	16.8	ns
26	Data output delay time (for HBUSCLK ↑)	t_{DKPHD}	2.0	10.0	ns
27	Data output delay time (for HBUSCLK ↓)	t_{DKNHD}	2.0	10.0	ns
28	HWAITZ output delay time (for HBUSCLK ↑)	t_{DKPHWT}	2.0	11.0	ns
29	HWAITZ output delay time (for HBUSCLK ↓)	t_{DKNHWT}	2.0	11.0	ns
30	Data output hold time (for HCSZ/HPGCSZ ↑)	t_{HKPHCS}	—	16.8	ns

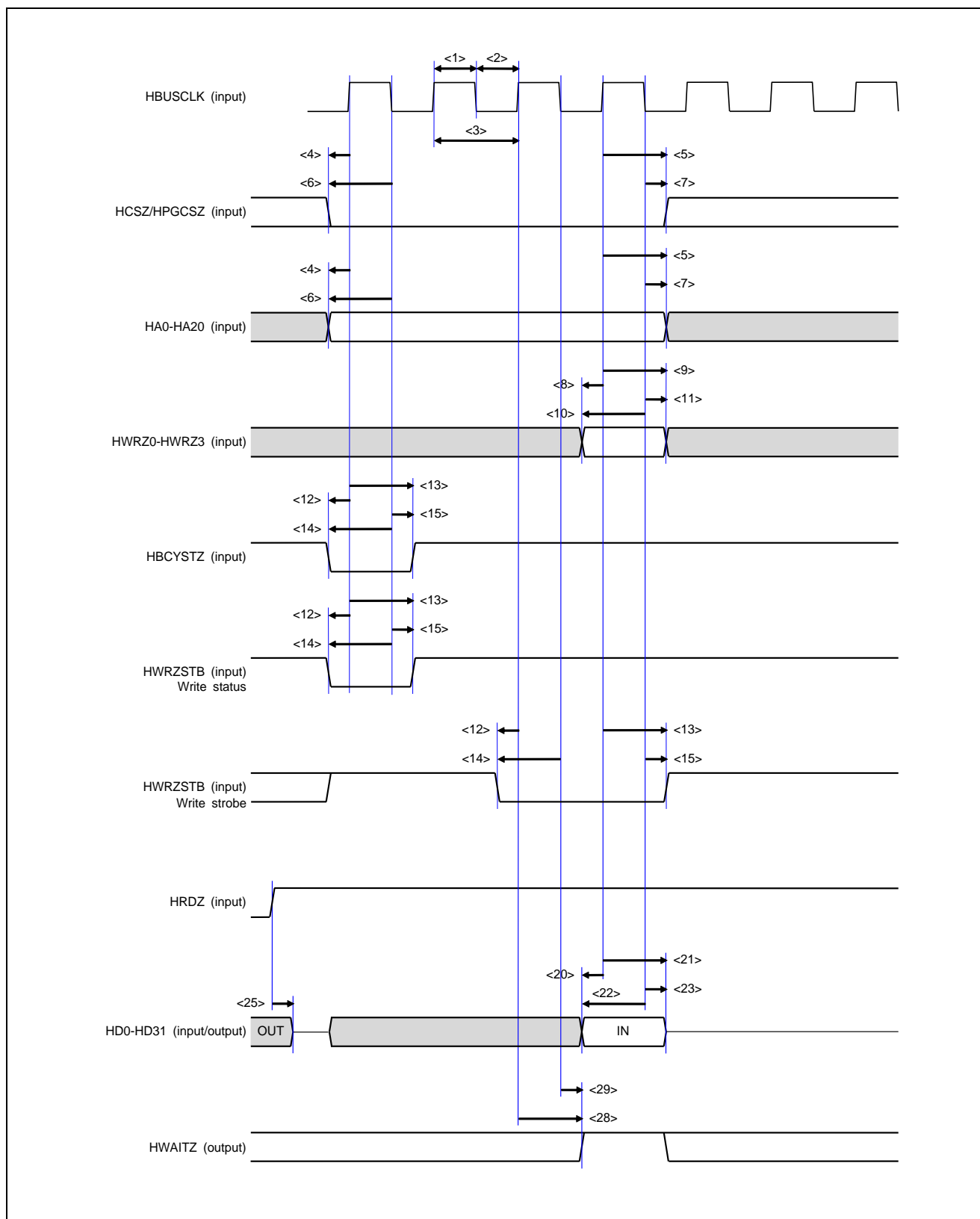


Figure 3.17 External MCU Interface Write Timing (MEMCSEL=H, ADMUXMODE=L)

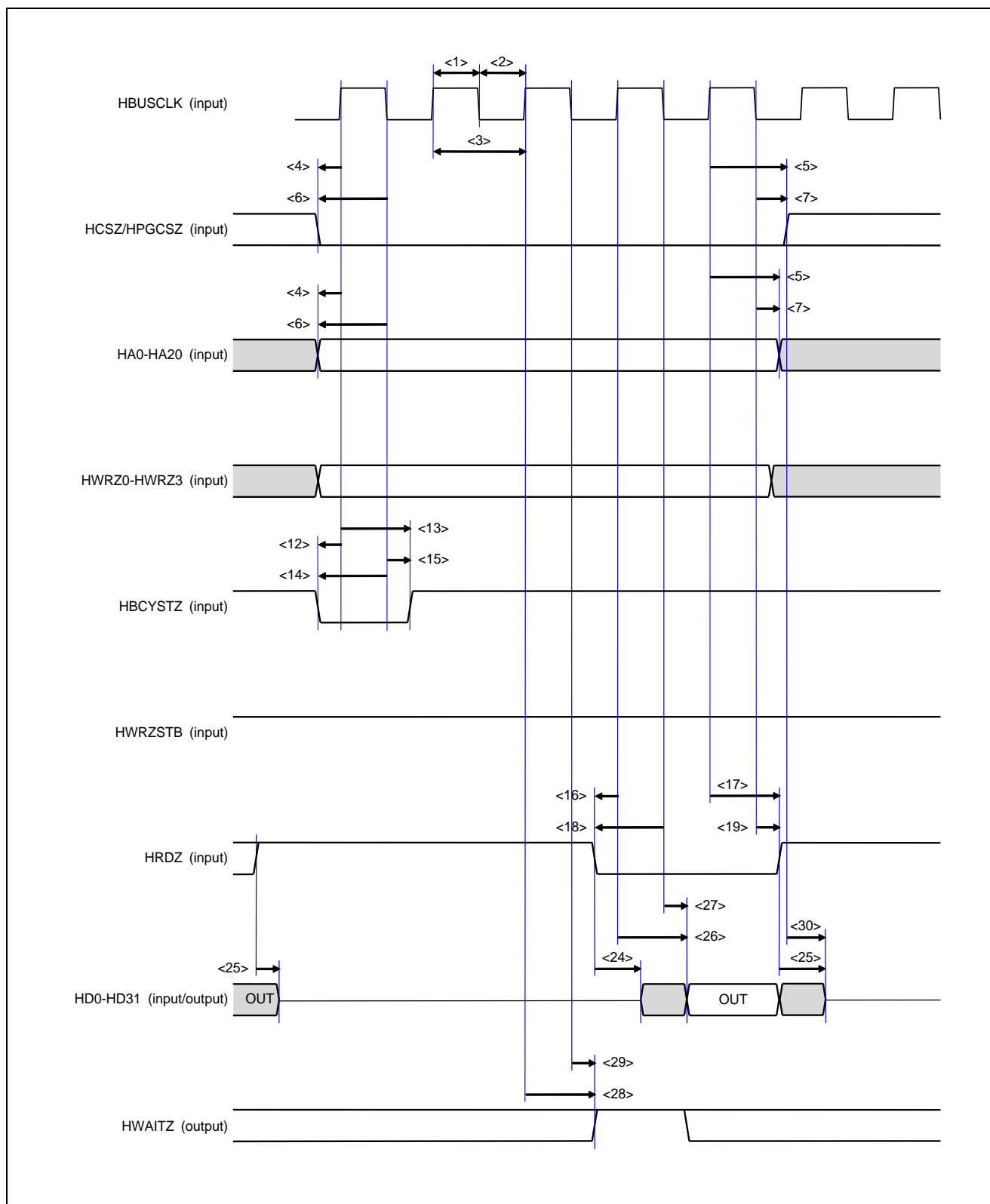


Figure 3.18 External MCU Interface Read Timing (MEMCSEL=H, ADMUXMODE=L)

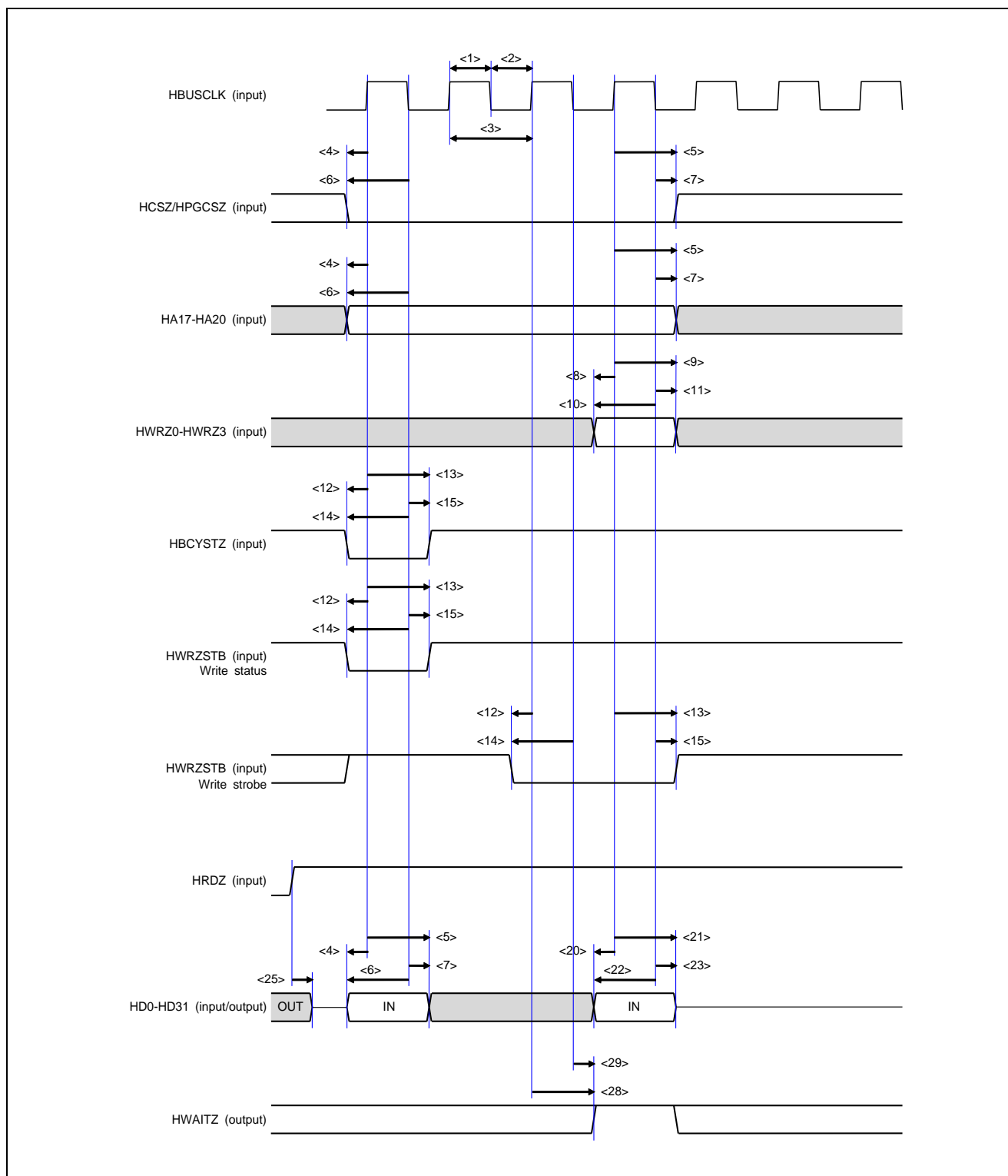


Figure 3.19 External MCU Interface Write Timing (MEMCSEL=H, ADMUXMODE=H)

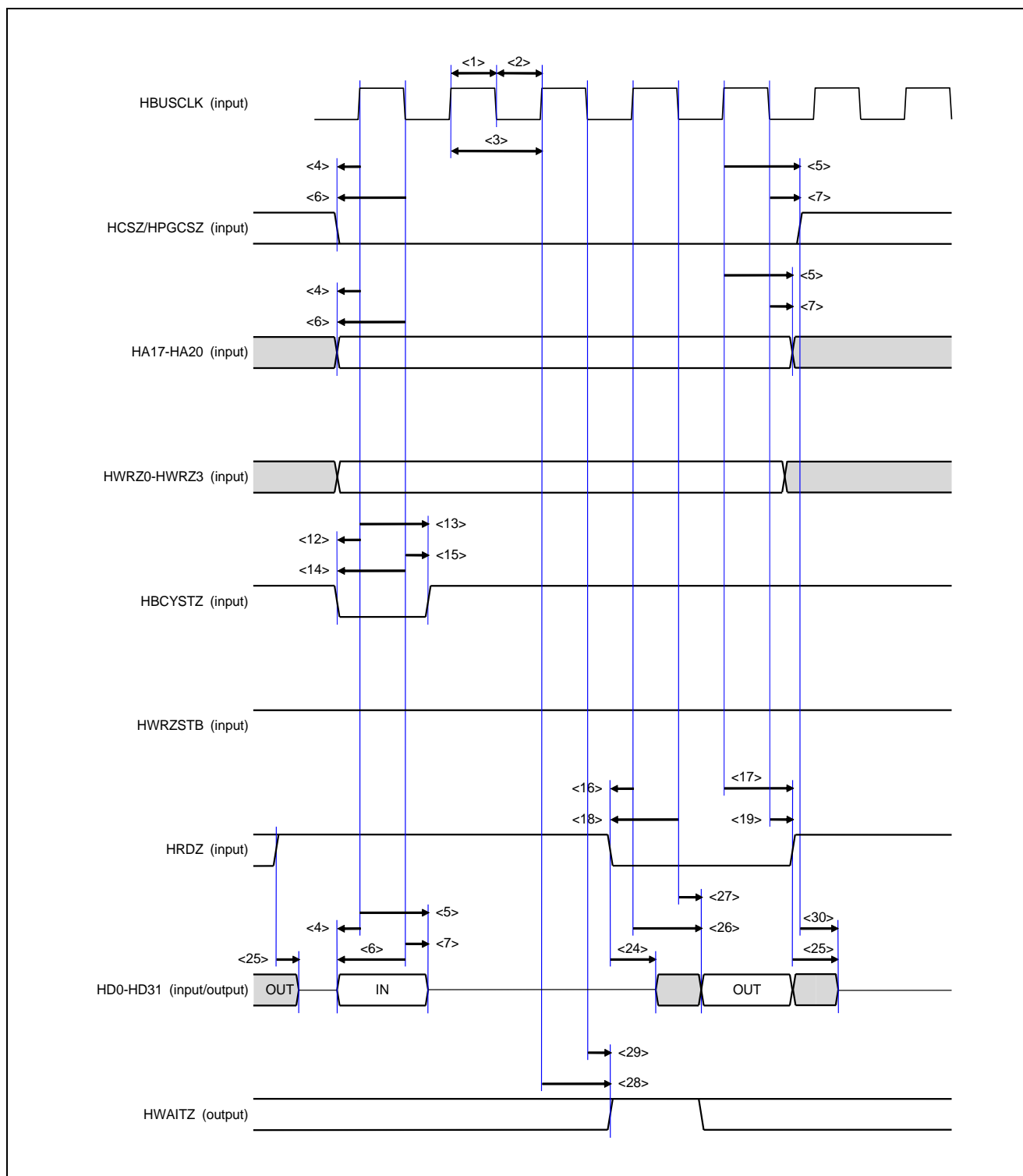


Figure 3.20 External MCU Interface Read Timing (MEMCSEL=H, ADMUXMODE=H)

3.8.5 Serial Flash ROM Interface

Item	Symbol	Conditions	MIN	MAX	Unit
SMSCK output cycle	t_{SFRCYC}	$C_L = 15\text{ pF}$	20	—	ns
SMSCK High-level width	t_{SMCKH}		$0.5 \times t_{SFRCYC} - 2.0$	$0.5 \times t_{SFRCYC} + 2.0$	ns
SMSCK Low-level width	t_{SMCKL}		$0.5 \times t_{SFRCYC} - 2.0$	$0.5 \times t_{SFRCYC} + 2.0$	ns
SMSCK rising time	t_{SMCKR}		—	1.9	ns
SMSCK falling time	t_{SMCKF}		—	1.9	ns
Delay time between SMCSZ falling and SMSCK rising	$t_{DSMCSCK}$	$C_L = 15\text{ pF}$, Freq = 50 MHz	6.0*	—	ns
Hold time from SMSCK rising to SMCSZ rising	$t_{DSMCKCS}$	$C_L = 15\text{ pF}$, Freq = 50 MHz	9.0*	—	ns
SMCSZ High-level width	t_{SMCSH}	$C_L = 15\text{ pF}$	14*	—	ns
SMIO0–SMIO3 input setup time (for SMSCK ↓)	t_{SSMIO}	—	6.0	—	ns
SMIO0–SMIO3 input hold time (for SMSCK ↓)	t_{HSMIO}	—	0	—	ns
SMIO0–SMIO3 output delay time (for SMSCK ↓)	t_{DSMIO}	$C_L = 15\text{ pF}$	–1.0	5.0	ns

Note. The timing can be extended by the setting of the SFMSSC register.

For details, refer to the “R-IN32M4-CL3 User’s Manual: Hardware edition”.

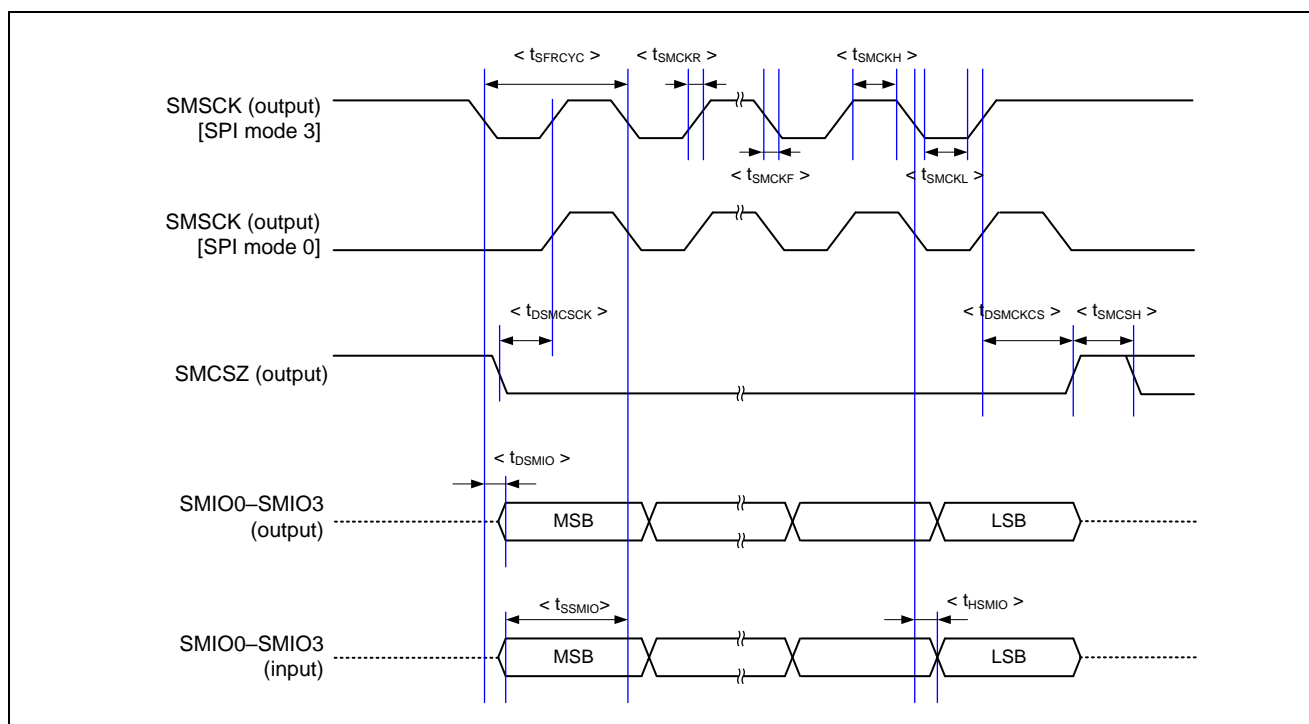


Figure 3.21 Serial Flash Memory Access Timing

3.8.6 External DMA Interface

Item	Symbol	Conditions	MIN	MAX	Unit
DMAREQZn and RTDMAREQZ input setup time (for BUSCLK ↑)	t_{SKDR}	—	7.0	—	ns
DMAREQZn and RTDMAREQZ input hold time 1	t_{HKDR1}	—	Until DMAACKZ↓, RTDMAACKZ↓	—	ns
DMAREQZn and REDMAREQZ input hold time 2 (for BUSCLK ↑)	t_{HKDR2}	—	—	$t_{BUSCLK}^{*1} \times m^{*2} - 7.0$	ns
DMAACKZn and RTDMAACKZ output delay time (for BUSCLK ↑)	t_{DKDA}	$C_L = 30 \text{ pF}$	2.0	10.0	ns
DMAACKZ and RTDMAACKZ output Low-level width	t_{WDAL}	—	$t_{BUSCLK}^{*1} \times m^{*2} - 8$	$t_{BUSCLK}^{*1} \times m^{*2} + 8$	ns
DMATCZn and RTDMATCZ output delay time (for BUSCLK ↑)	t_{DKTC}	$C_L = 30 \text{ pF}$	2.0	10.0	ns

Note 1. t_{BUSCLK} is one cycle (10 ns) of BUSCLK.

2. $n = 0, 1$, $m = 1-31$ (DMAIFC0, DMAIFC1, and RTMDAIFC registers)

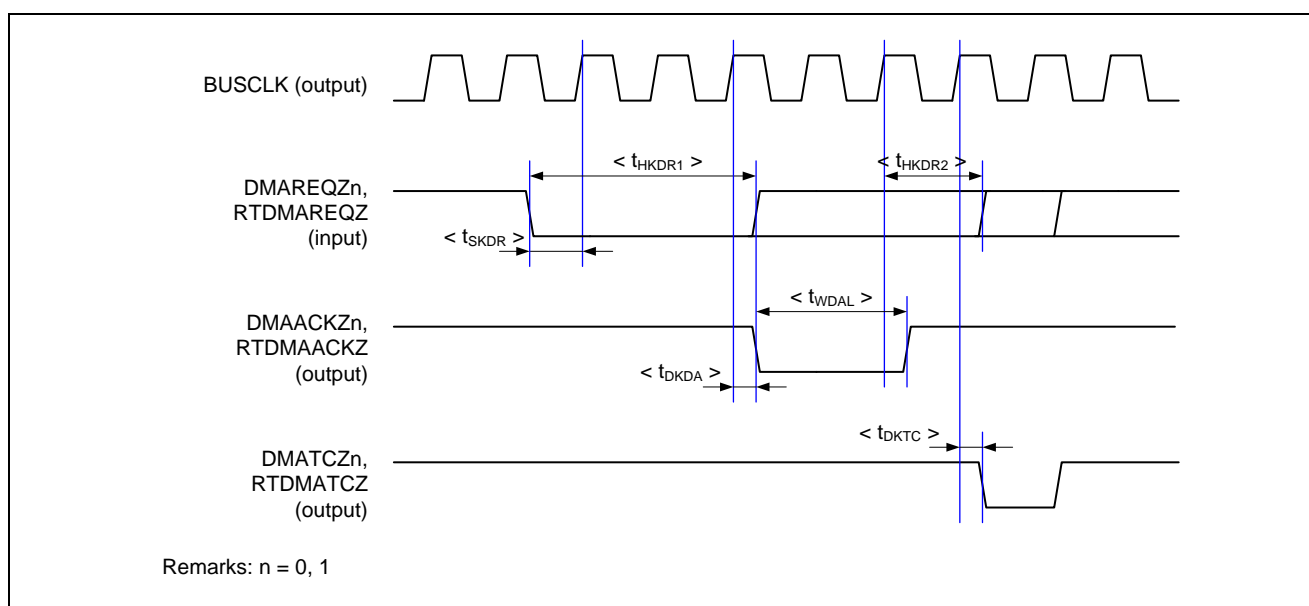


Figure 3.22 External DMA Access Timing

3.8.7 CSI Interface

The clocked serial interface (CSI) supports master mode and slave mode.

(1) Master mode

Item	Symbol	Conditions	MIN	MAX	Unit
CSISCKn output cycle	t_{CSIMSCK}	$C_L = 15 \text{ pF}$	40	—	ns
CSISCKn output High-level width	t_{WSKH}	$C_L = 15 \text{ pF}$	$0.5 \times t_{\text{CSIMSCK}} - 5.0$	—	ns
CSISCKn output Low-level width	t_{WSKL}	$C_L = 15 \text{ pF}$	$0.5 \times t_{\text{CSIMSCK}} - 5.0$	—	ns
CSISIn input setup time (for CSISCKn \uparrow)	t_{SMSI}	—	8.5	—	ns
CSISIn input setup time (for CSISCKn \downarrow)	t_{SMSI}	—	8.5	—	ns
CSISIn input hold time (for CSISCKn \uparrow)	t_{HMSI}	—	7.0	—	ns
CSISIn input hold time (for CSISCKn \downarrow)	t_{HMSI}	—	7.0	—	ns
CSISOn output delay time (for CSISCKn \uparrow)	t_{DMSO}	$C_L = 15 \text{ pF}$	—	7.0	ns
CSISOn output delay time (for CSISCKn \downarrow)	t_{DMSO}		—	7.0	ns
CSISOn output hold time (for CSISCKn \uparrow)	t_{HMSO}		$0.5 \times t_{\text{CSIMSCK}} - 5.0$	—	ns
CSISOn output hold time (for CSISCKn \downarrow)	t_{HMSO}		$0.5 \times t_{\text{CSIMSCK}} - 5.0$	—	ns

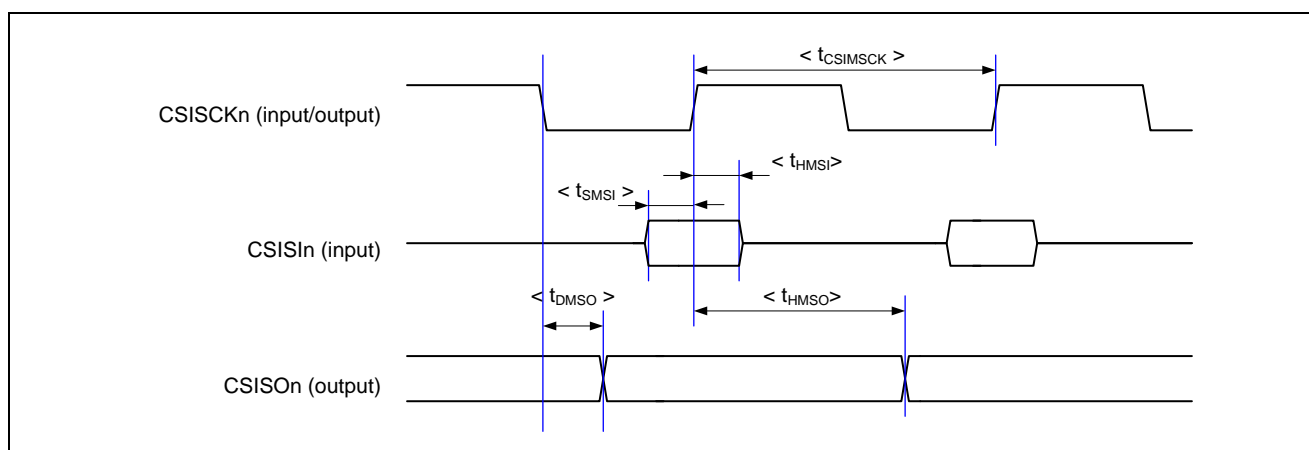


Figure 3.23 CSI Access Timing (Master Mode)

Remarks 1. $n = 0, 1$

- The above is an example of the timing for data output of "for CSISCKn \downarrow " and data input of "for CSISCKn \uparrow ". Read the timing for reference in accordance with the operating mode.

(2) Slave mode

Item	Symbol	Conditions	MIN	MAX	Unit
CSISCKn input cycle	$t_{CSISSCK}$	—	60	—	ns
CSISCKn input High-level width	t_{WSKH}	—	$0.5 \times t_{CSISSCK} - 5.0$	—	ns
CSISCKn input Low-level width	t_{WSKL}	—	$0.5 \times t_{CSISSCK} - 5.0$	—	ns
CSISIn input setup time (for CSISCKn ↑)	t_{SSSI}	—	10.0	—	ns
CSISIn input setup time (for CSISCKn ↓)	t_{SSSI}	—	10.0	—	ns
CSISIn input hold time (for CSISCKn ↑)	t_{HSSI}	—	15	—	ns
CSISIn input hold time (for CSISCKn ↓)	t_{HSSI}	—	15	—	ns
CSISOn output delay time (for CSISCKn ↑)	t_{DSSO}	$C_L = 15 \text{ pF}$	—	10.0	ns
CSISOn output delay time (for CSISCKn ↓)	t_{DSSO}		—	10.0	ns
CSISOn output hold time (for CSISCKn ↑)	t_{HSSO}		$0.5 \times t_{CSISSCK} - 5.0$	—	ns
CSISOn output hold time (for CSISCKn ↓)	t_{HSSO}		$0.5 \times t_{CSISSCK} - 5.0$	—	ns

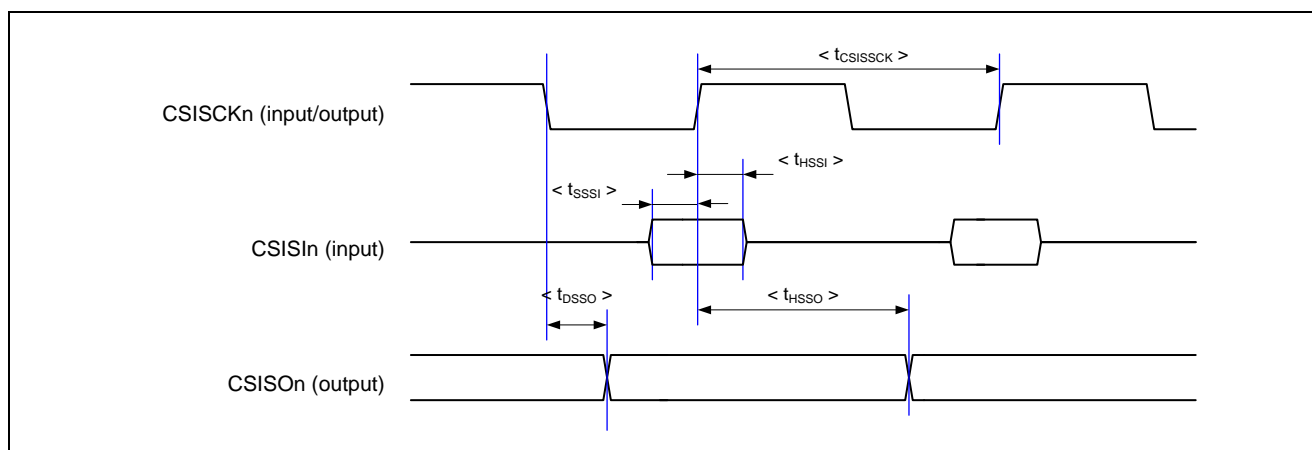


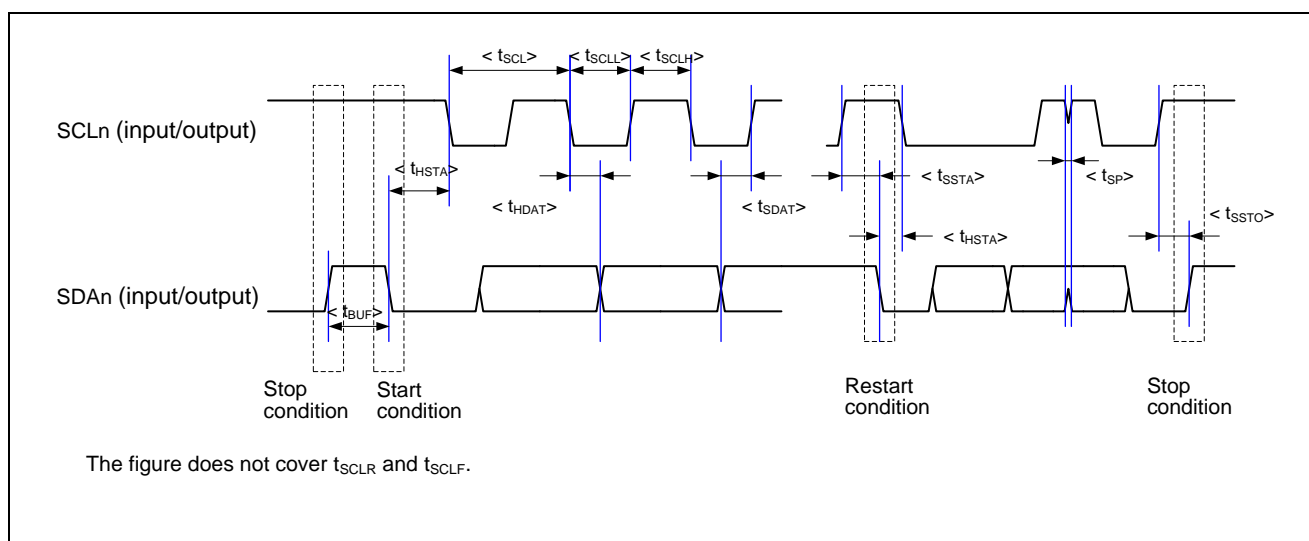
Figure 3.24 CSI Access Timing (Slave Mode)

Remarks 1. $n = 0, 1$

- The above is an example of the timing for data output of "for CSISCKn ↓" and data input of "for CSISCKn ↑". Read the timing for reference in accordance with the operating mode.

3.8.8 I²C Interface

Item		Symbol	Conditions	Normal Mode		High-Speed Mode		Unit
				MIN	MAX	MIN	MAX	
SCLn input/output frequency		t _{SCL}	C _L = 30 pF	0	100	0	400	kHz
Bus-free time between the stop condition and start condition		t _{BUF}		4.7	—	1.3	—	μs
Hold time		t _{HSTA}		4.0	—	0.6	—	μs
SCLn clock Low-level width		t _{SCLL}		4.7	—	1.3	—	μs
SCLn clock High-level width		t _{SCLH}		4.0	—	0.6	—	μs
Setup time for the start and restart conditions		t _{SSTA}		4.7	—	0.6	—	μs
Data hold time	For a CBUS compatible master	t _{HDATA}		5.0	—	—	—	μs
	For an I ² C bus			0	—	0	0.9	μs
Data setup time		t _{SDAT}		250	—	100	—	ns
SDAn and SCLn rising time		t _{SCLR}		—	1000	20 + 0.1 × C _b	300	ns
SDAn and SCLn falling time		t _{SCLF}		—	300	20 + 0.1 × C _b	300	ns
Setup time for the stop condition		t _{SSTO}	4.0	—	0.6	—	μs	
Pulse width of spike suppressed by input filter		t _{SP}	—	—	0	50	ns	
Capacitive load of each bus line		C _b	—	400	—	400	pF	

Figure 3.25 I²C Access Timing**Remark.** n = 0, 1

3.8.9 CAN Interface

Item	Symbol	Conditions	MIN	MAX	Unit
Internal delay time	t_{NODE}	$C_L = 30 \text{ pF}$	—	75	ns

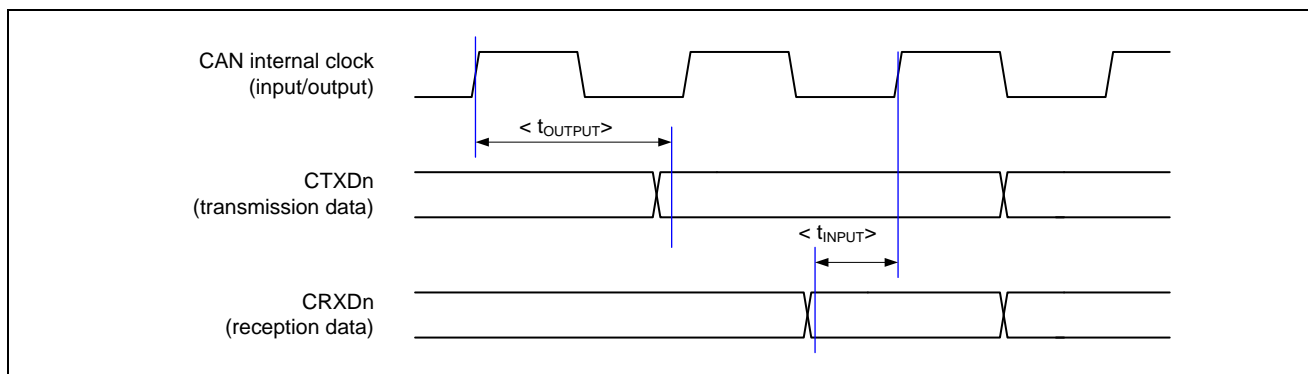


Figure 3.26 CAN Access Timing

Internal delay time (t_{NODE}) = Internal transmission delay time (t_{OUTPUT}) + Internal reception delay time (t_{INPUT})

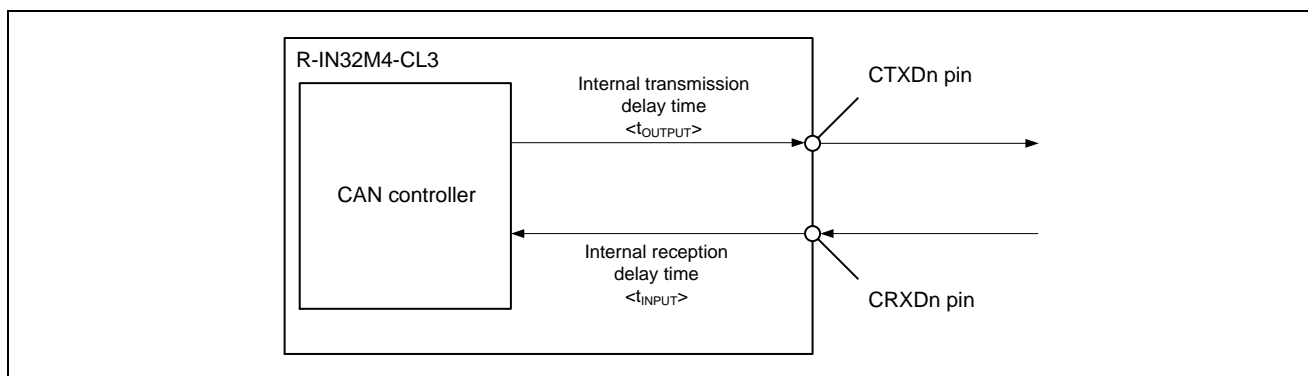


Figure 3.27 CAN Access Timing (Supplement)

- Remarks 1.** $n = 0, 1$
- 2.** CAN internal clock (f_{CAN}): CAN baud-rate clock

3.8.10 Debugging Interface

(1) Debugging Serial Interface

Item	Symbol	Conditions	MIN	MAX	Unit
TCK input cycle	t_{TCK}	—	20	—	ns
TMS input setup time (for TCK ↑)	t_{STMS}	—	6.5	—	ns
TMS input hold time (for TCK ↑)	t_{HTMS}	—	0	—	ns
TDI input setup time (for TCK ↑)	t_{STDI}	—	6.5	—	ns
TDI input hold time (for TCK ↑)	t_{HTDI}	—	0	—	ns
TDO output delay time (for TCK ↓)	t_{DTDO}	$C_L = 30\text{ pF}$	3.0	13.0	ns

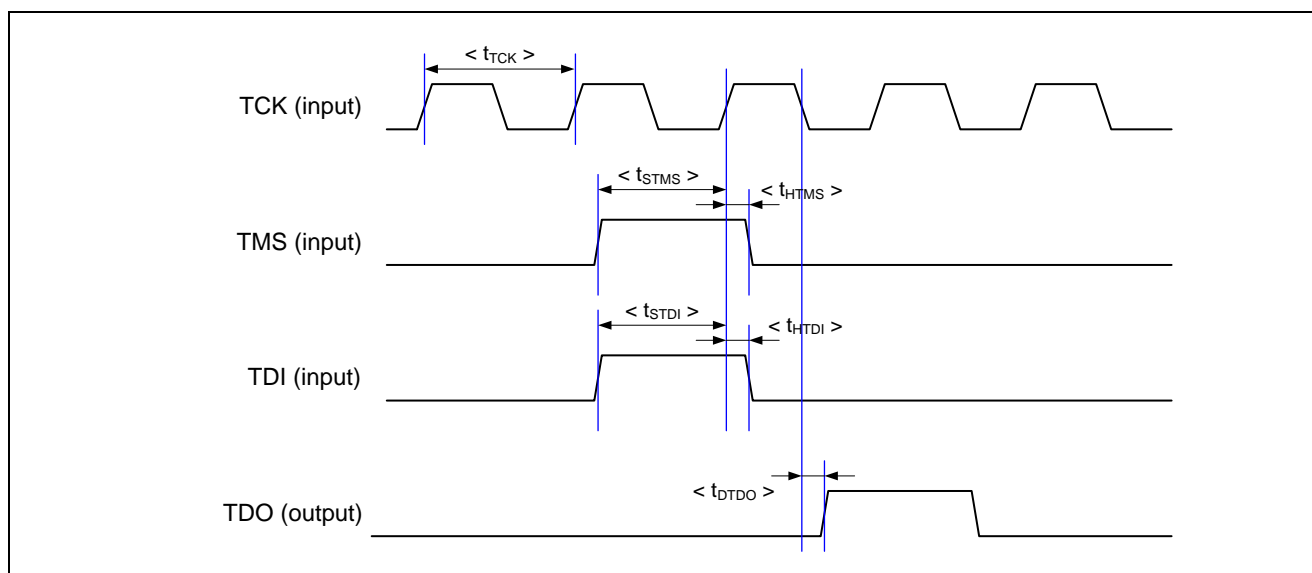


Figure 3.28 Debugging Serial Interface

(2) Trace Interface

Item	Symbol	Conditions	MIN	MAX	Unit
TRACECLK output cycle	t_{TRCCLK}	$C_L = 15\text{ pF}$	20	—	ns
TRACEDATAn output delay time (for TRACECLK)	$t_{DTRCDAT}$	$C_L = 15\text{ pF}$	0.26	8.43	ns

Remark. n = 0–3

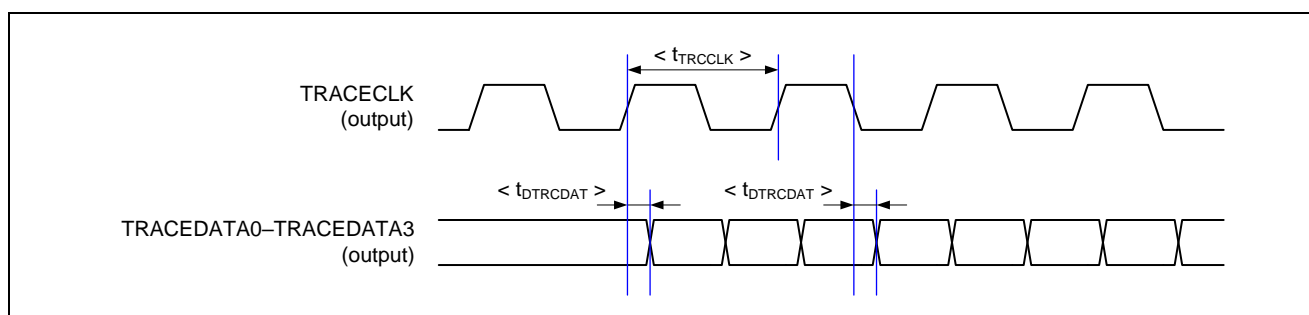


Figure 3.29 Trace Interface

3.9 2.5-V built-in Regulator Characteristics

Item	Symbol	Conditions	MIN	MAX	Unit
VDD25A rising time	$t_{VDD25AH}$	REG_EN = High	—	1*1	ms
VDD25A falling time	$t_{VDD25AL}$	REG_EN = High	—	—*2	ms

Note 1. This specification is based on the peripheral circuit configuration shown in the “R-IN32M4-CL3 User’s Manual: Board design edition”.

2. There is no timing specification when the AVDDREG_33 and VDDREG_33 are falling since the power will be turned off.

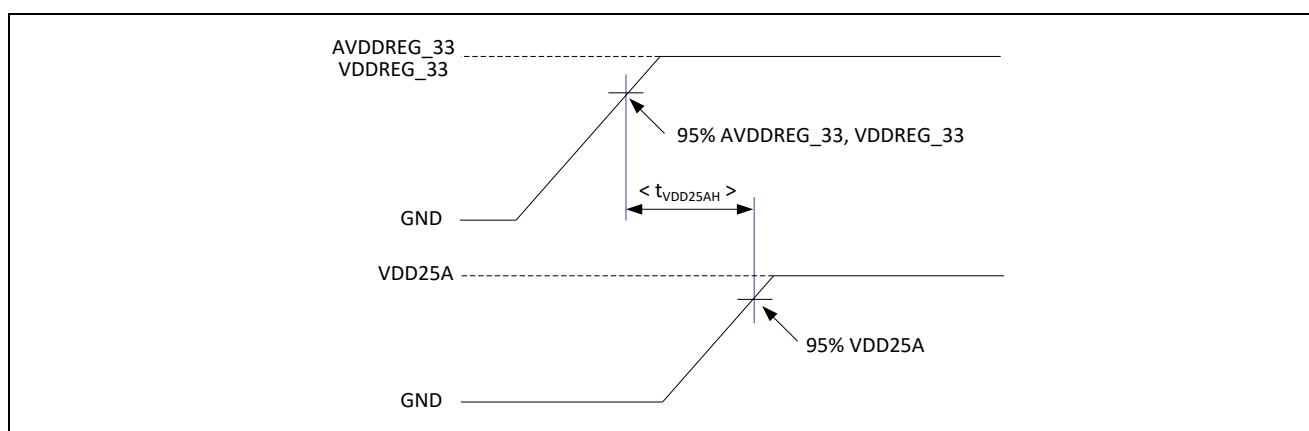


Figure 3.30 VDD25A rise timing

REVISION HISTORY

Rev.	Date	Description	
		Page	Summary
1.00	Nov 21, 2019	—	First Edition issued

General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity.

Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

6. Voltage application waveform at input pin

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between V_{IL} (Max.) and V_{IH} (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between V_{IL} (Max.) and V_{IH} (Min.).

7. Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

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